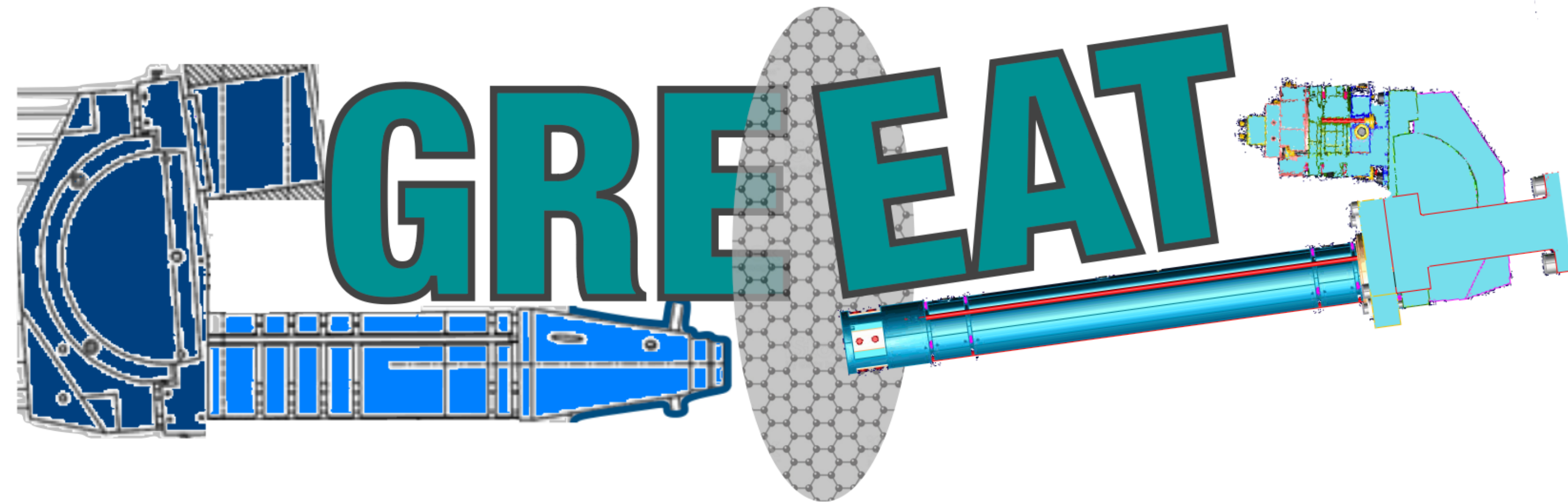




GGraphene to Electrons: Energy and Angular resolved Transmission

Alice Apponi, Orlando Castellano, Martina Chirico, Alessandro Ruocco

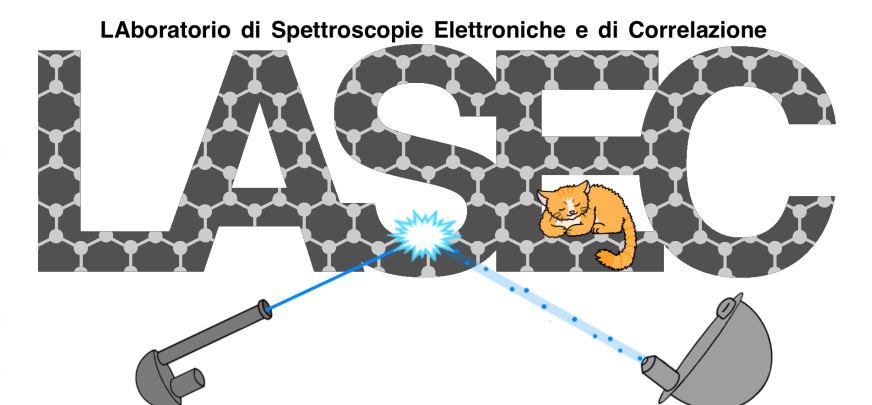
Young Researcher Grant CSN5 - 2 years project 2025/2027

INFN Sezione di Roma Tre and

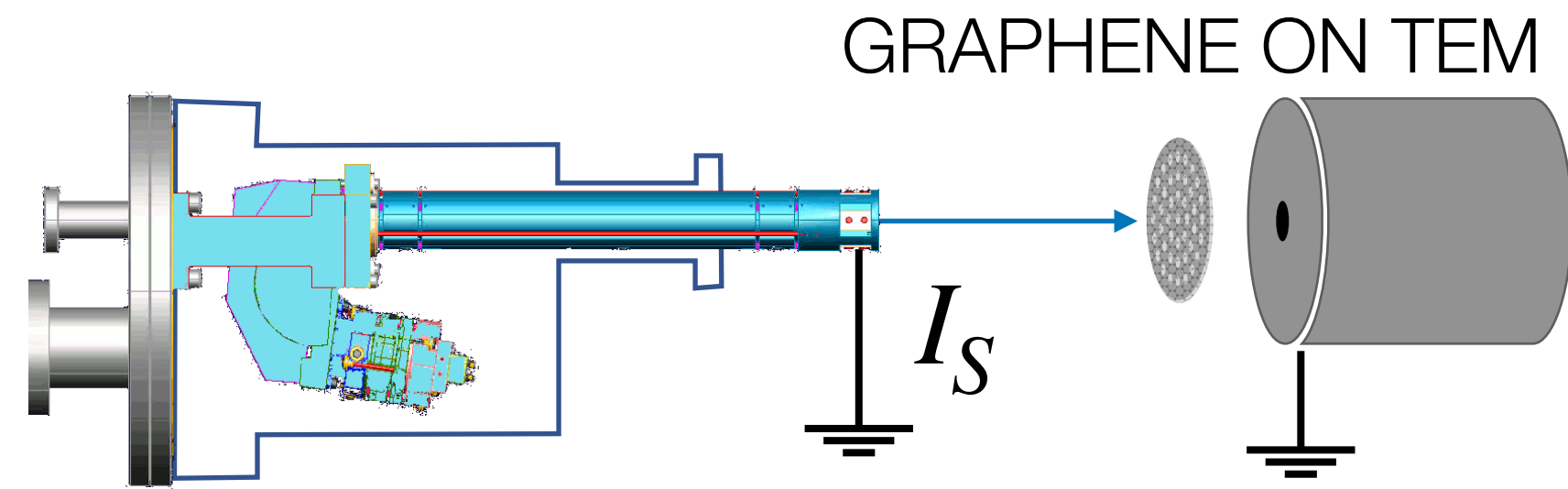
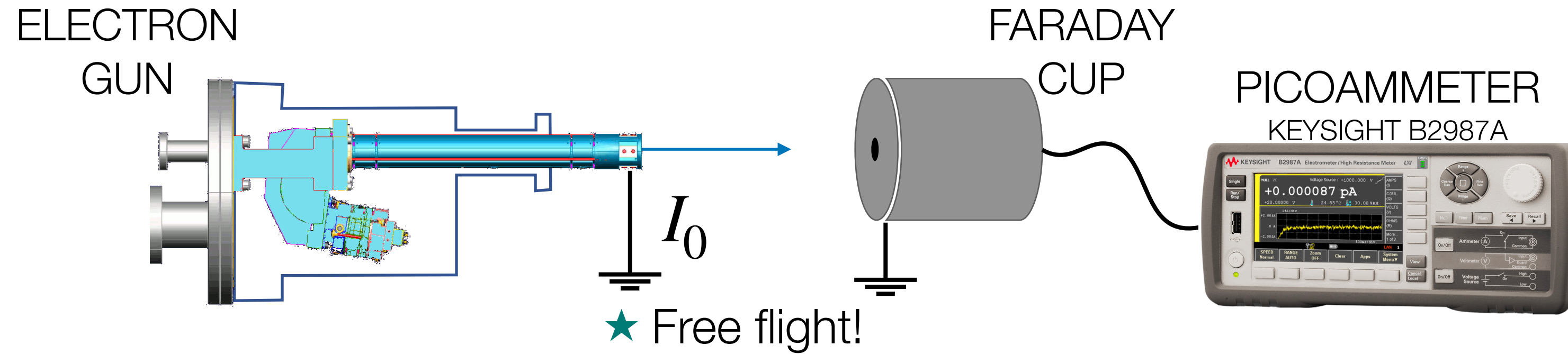
Dipartimento di Scienze, Università degli Studi Roma Tre

PTOLEMY General Meeting:

Nijmegen - 01.07.2025



Graphene Transmission Measured in the 30 - 900 eV Range

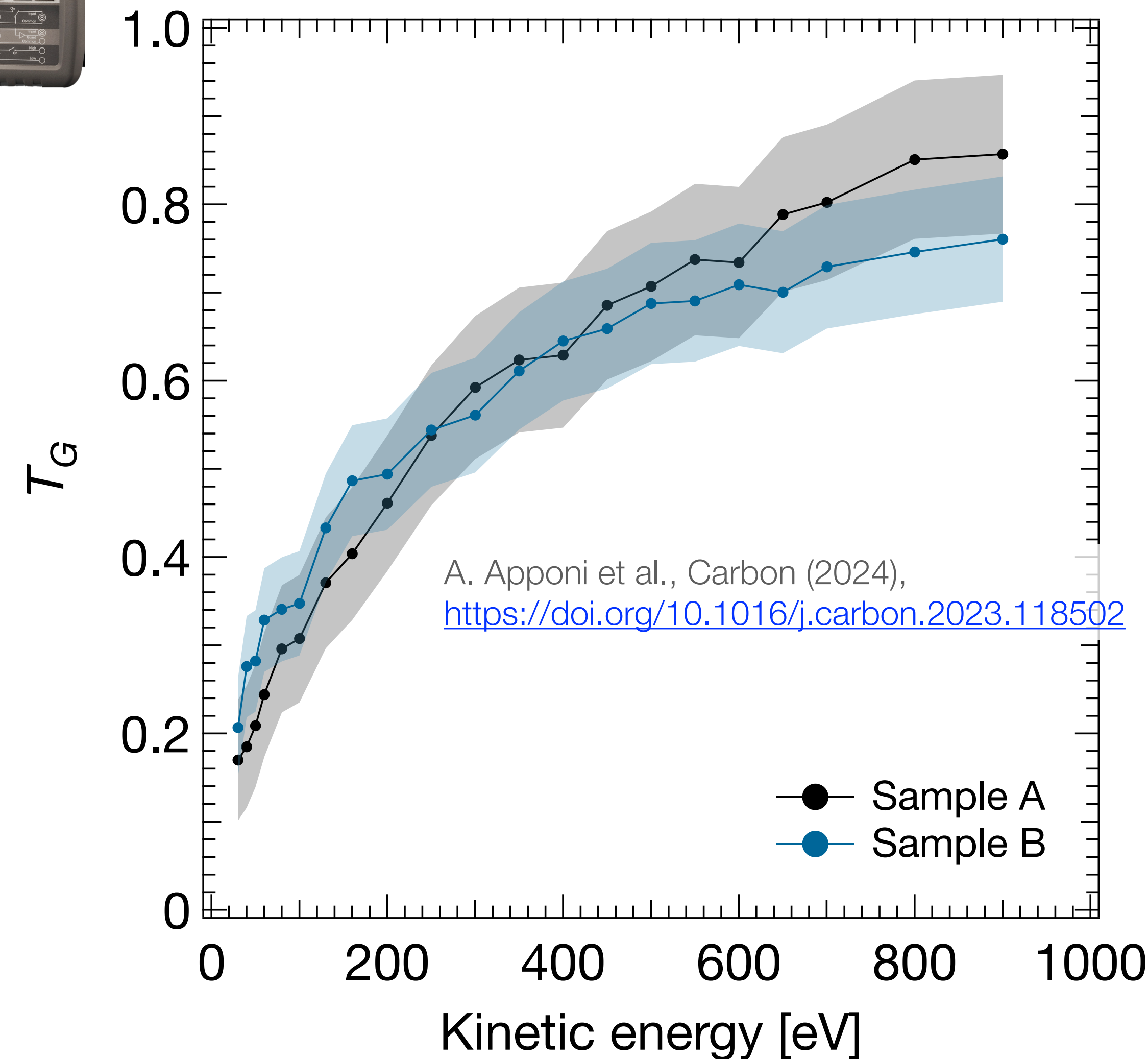


$$I_S(E) = a[I_0 T_{grid} T_G(E)] + b[I_0 T_{grid}]$$

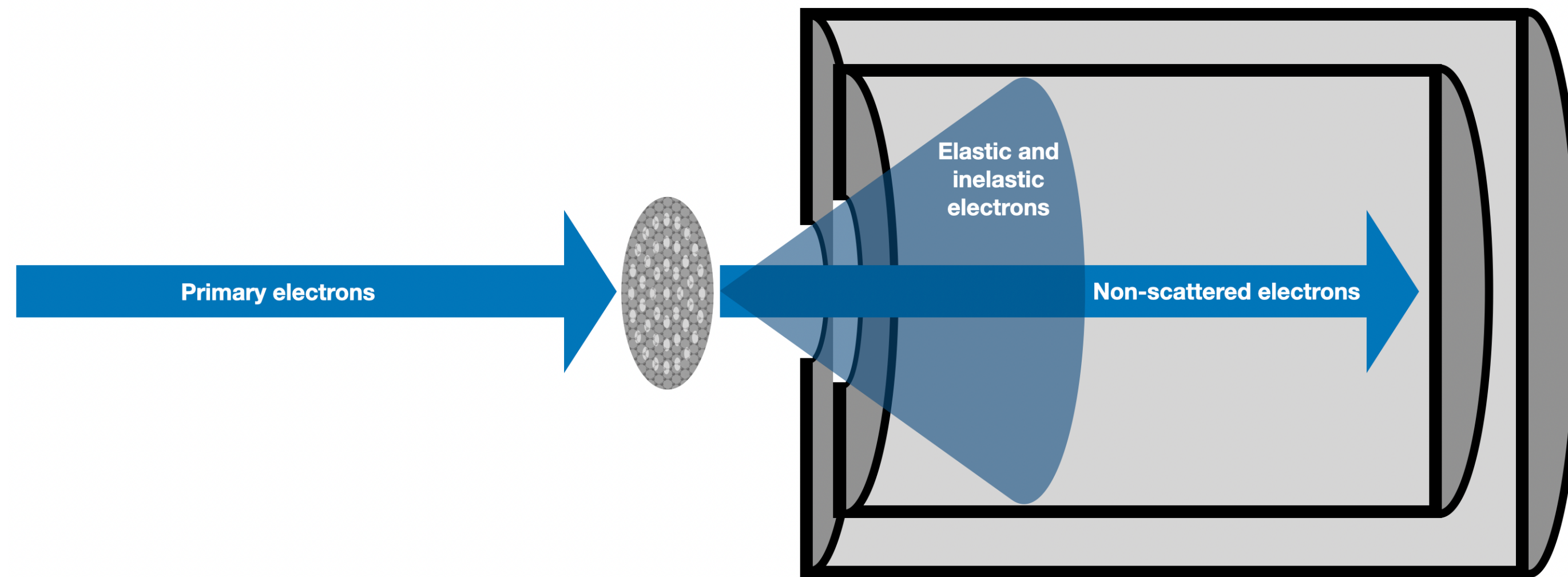
$a + b = 1$

Graphene coverage

$$T_G(E) = \frac{\frac{I_S}{I_0 T_{grid}} - b}{a}$$



Energy Resolution for Direct Measurement of Total Cross-Section



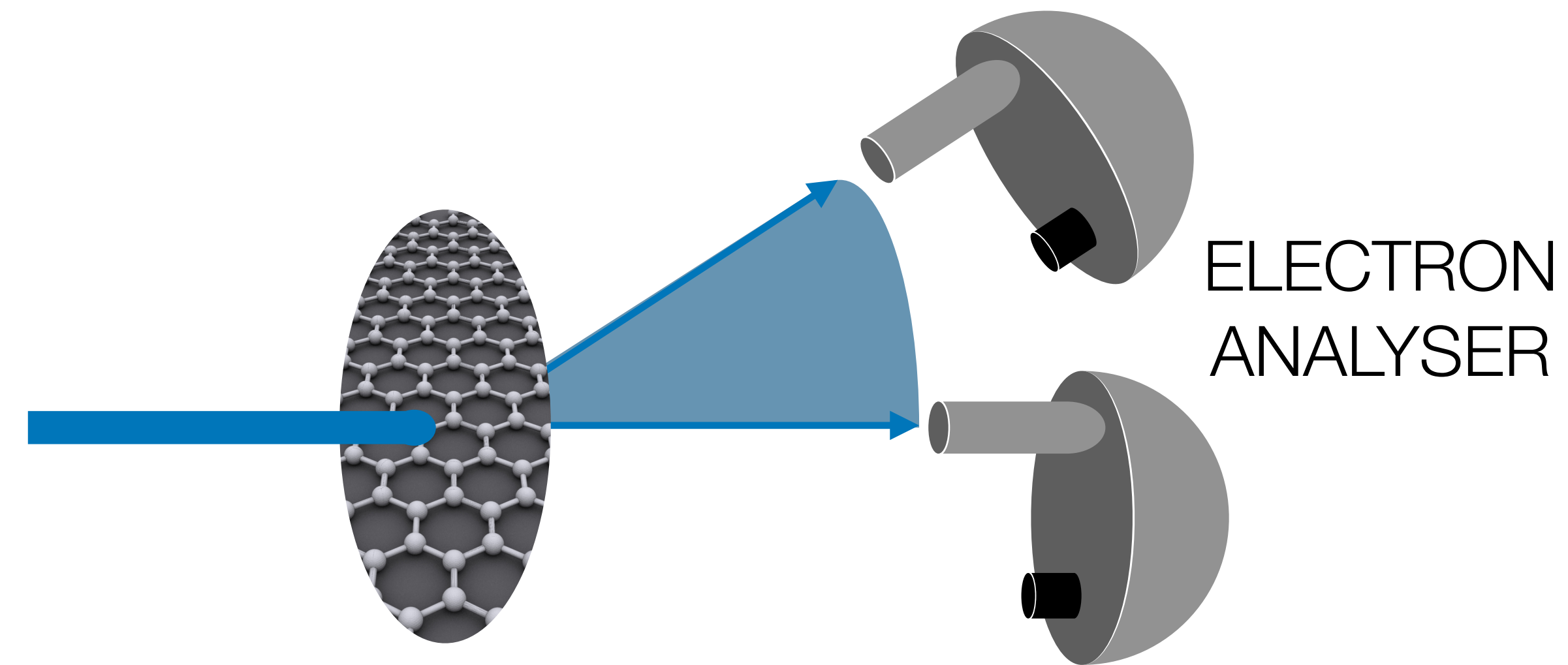
Integral measurement:

- ❖ No energy selection
- ❖ Current integrated within angular acceptance
- ❖ Result setup-dependent



Differential measurement:

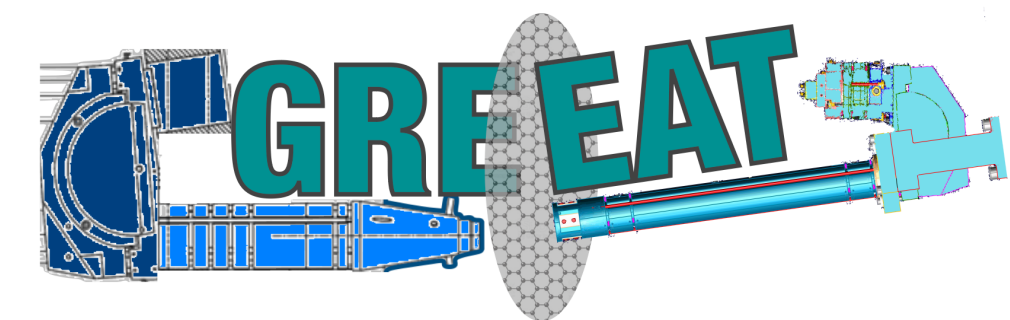
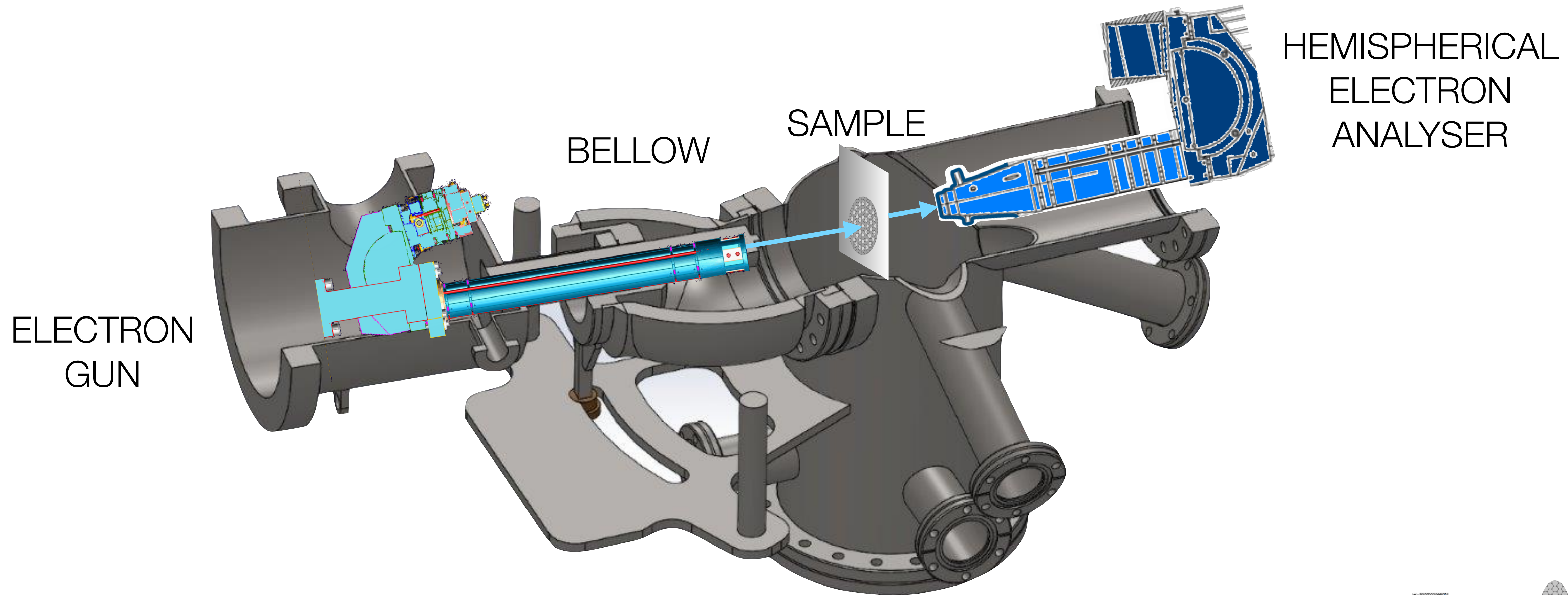
- ❖ Energy and momentum selection with hemispherical electron analyser
- ❖ Direct measurement of σ_{tot} = total cross-section
- ❖ Moveable setup for differential cross-section



$$I(E) = I_0 e^{-n_G \sigma_{tot}(E)}$$

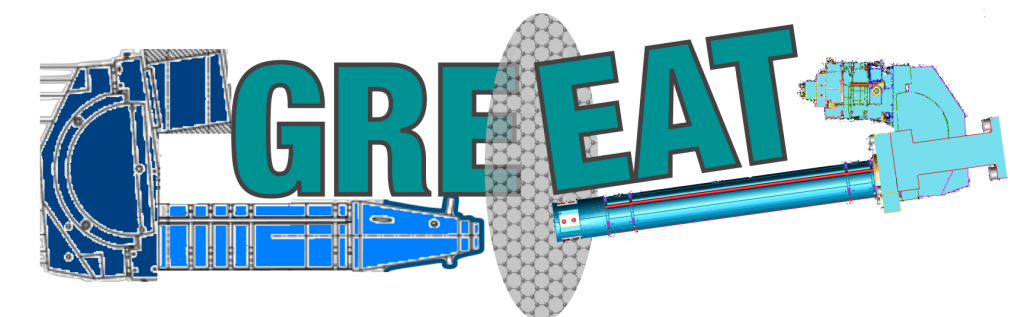
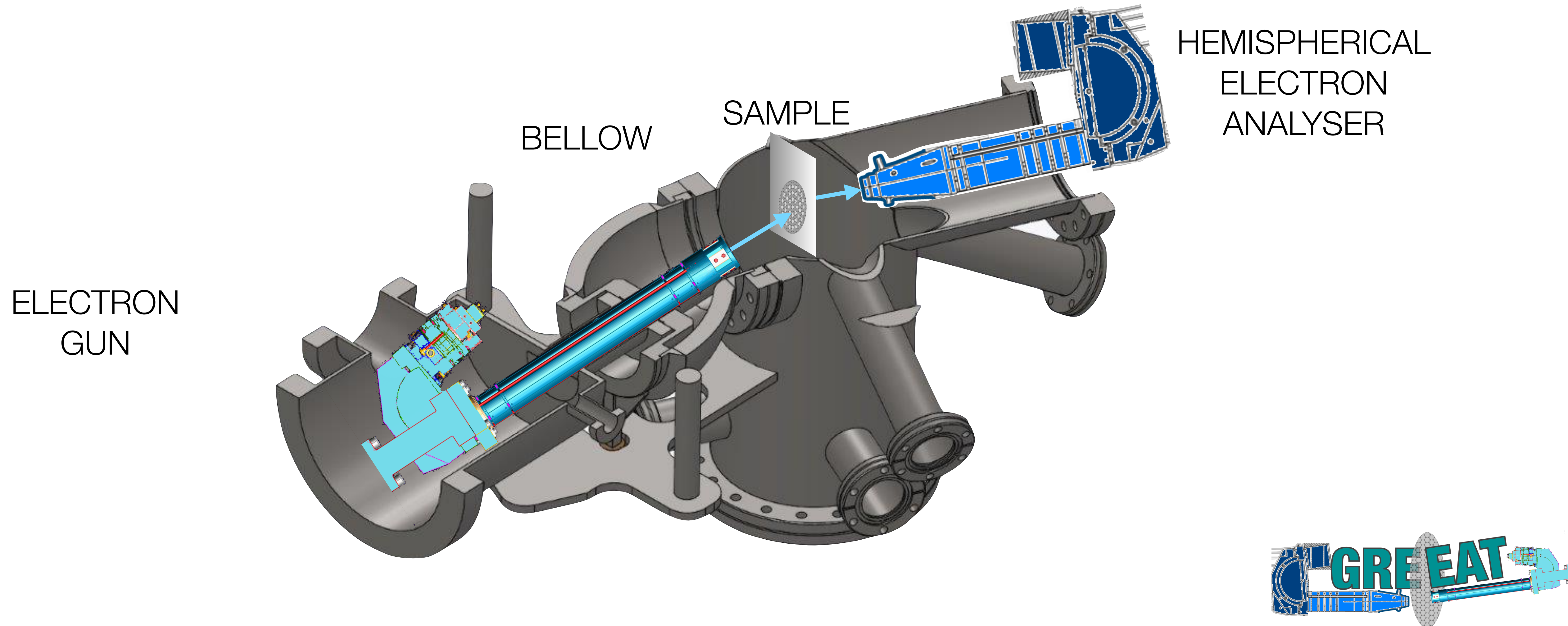
Moveable Electron Source for Angular Dependent Measurement

The TRAM-Chamber

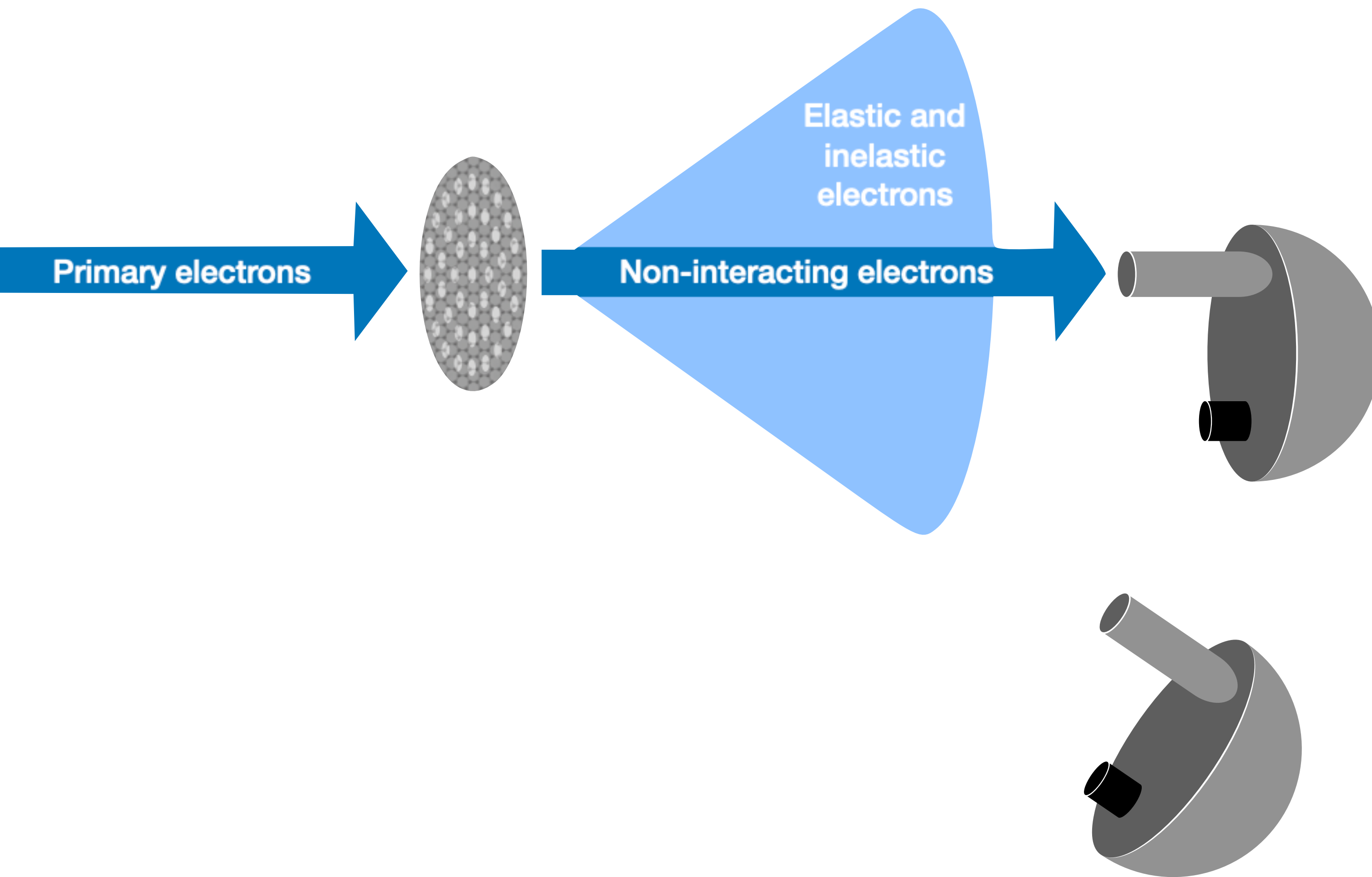


Moveable Electron Source for Angular Dependent Measurement

The TRAM-Chamber



Start With Non-Interacting e⁻ then Map Scattered e⁻



Non-interacting electrons:

- ❖ Measure at fixed “0 angle” (1° angular acceptance)
- ❖ Total cross-section

I year goal

Scattered electrons:

- ❖ Measure as a function of the angle and of the energy
- ❖ Differential and total cross-section

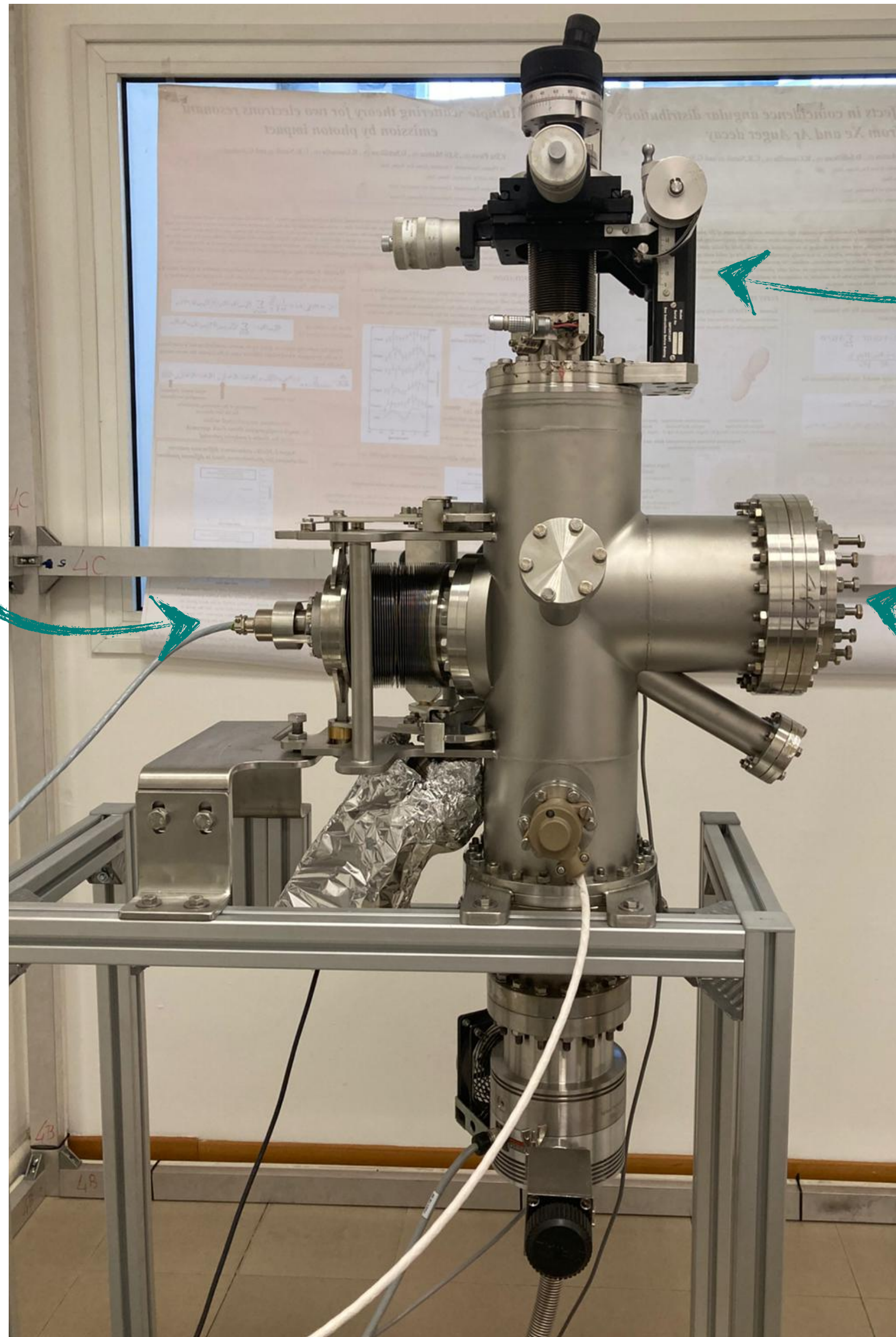
II year goal

The TRAM-Chamber is Up and Running!

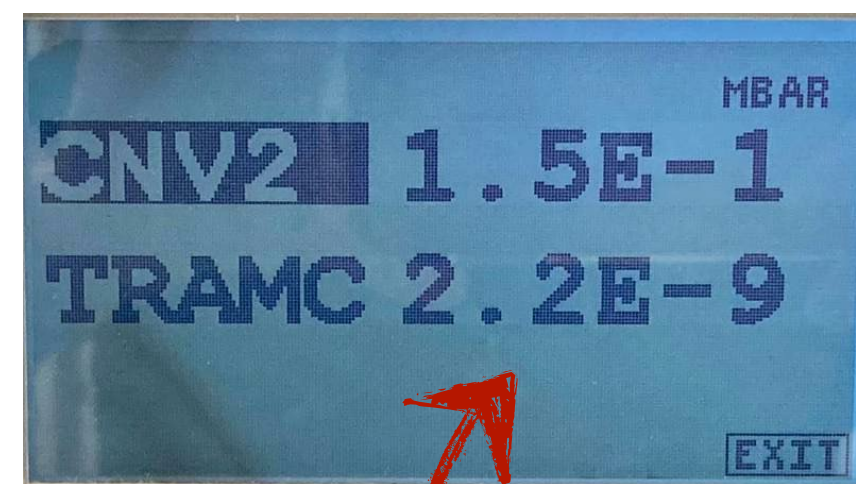
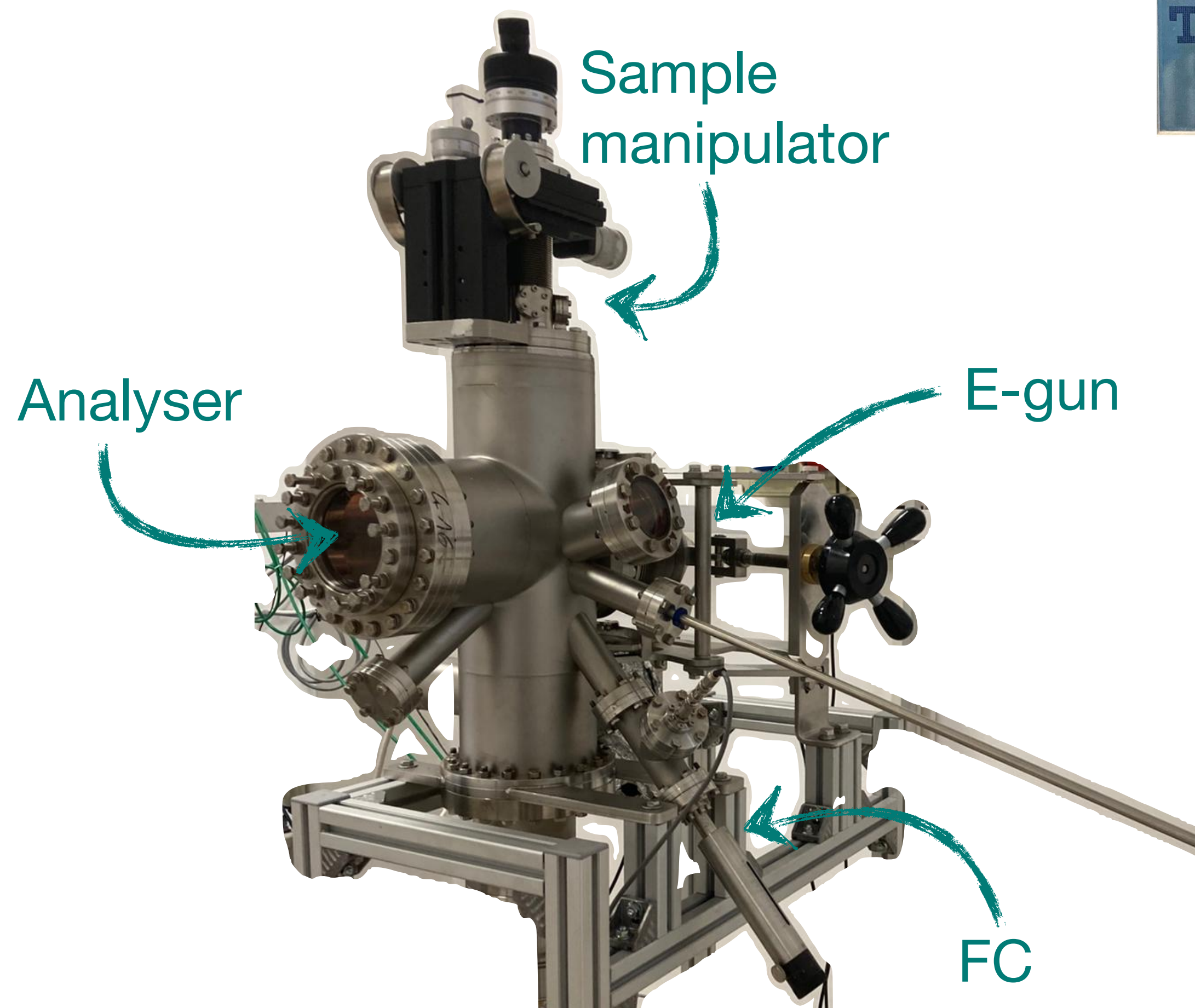
E-gun

Sample
manipulator

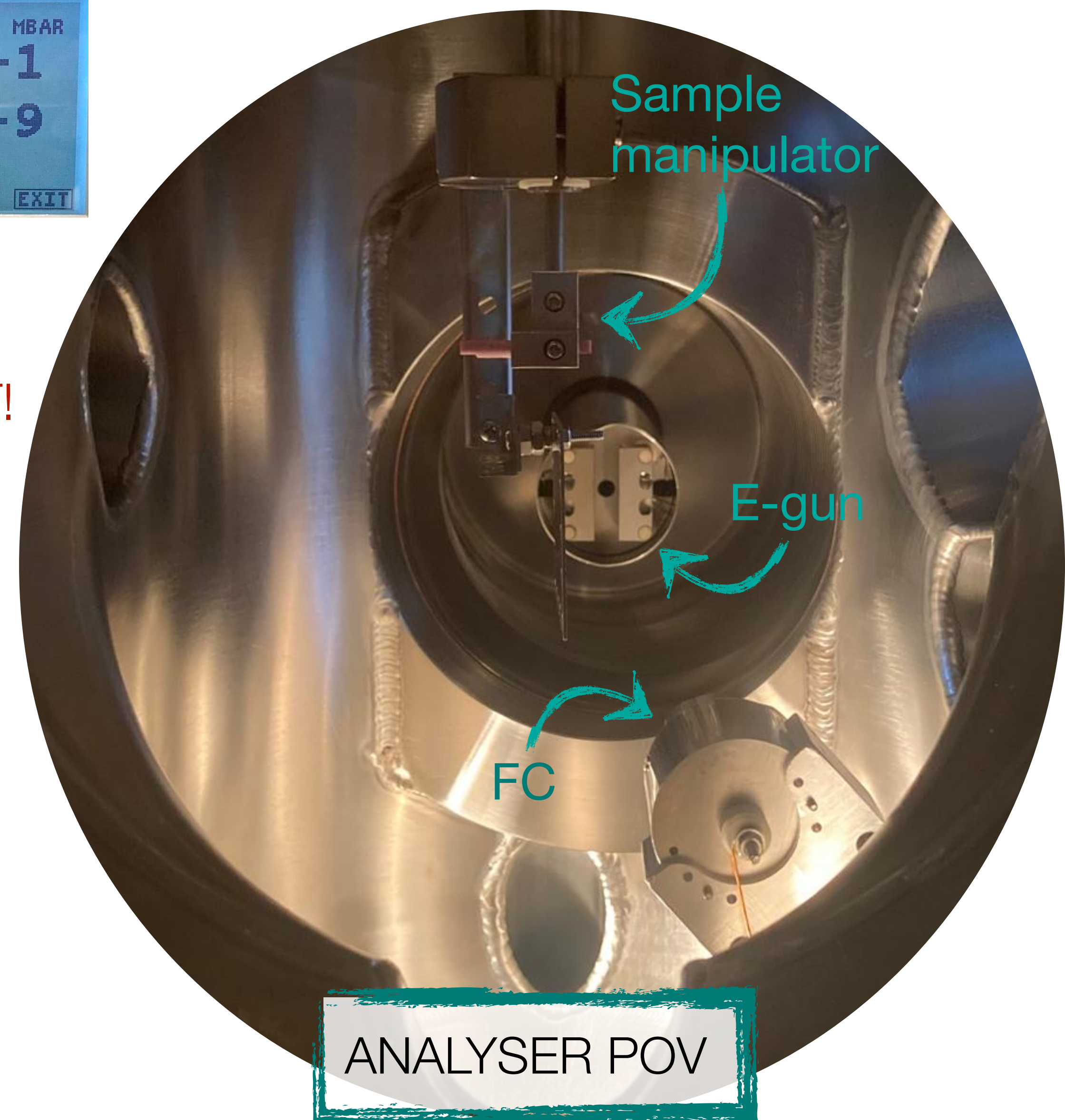
Analyser



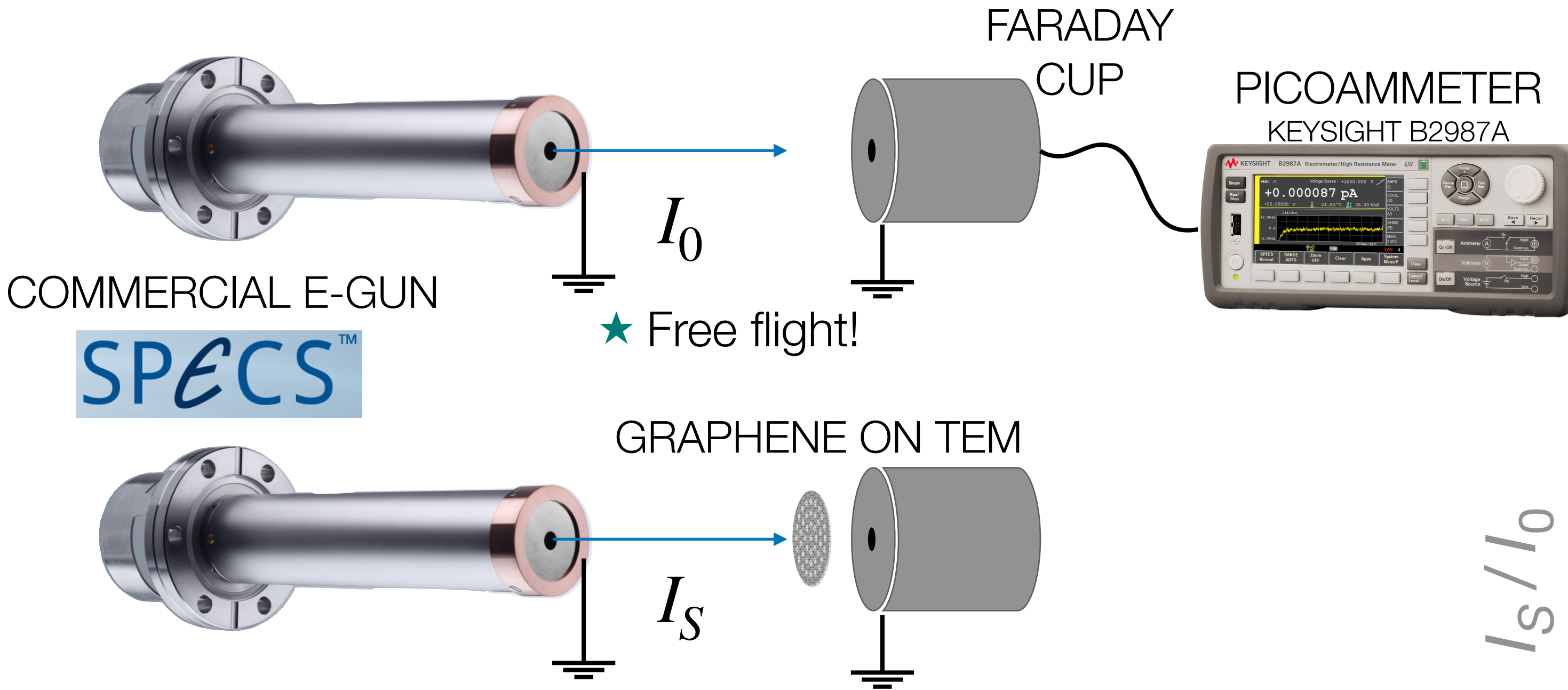
The TRAM-Chamber is Up and Running!



Without
BAKE-OUT!



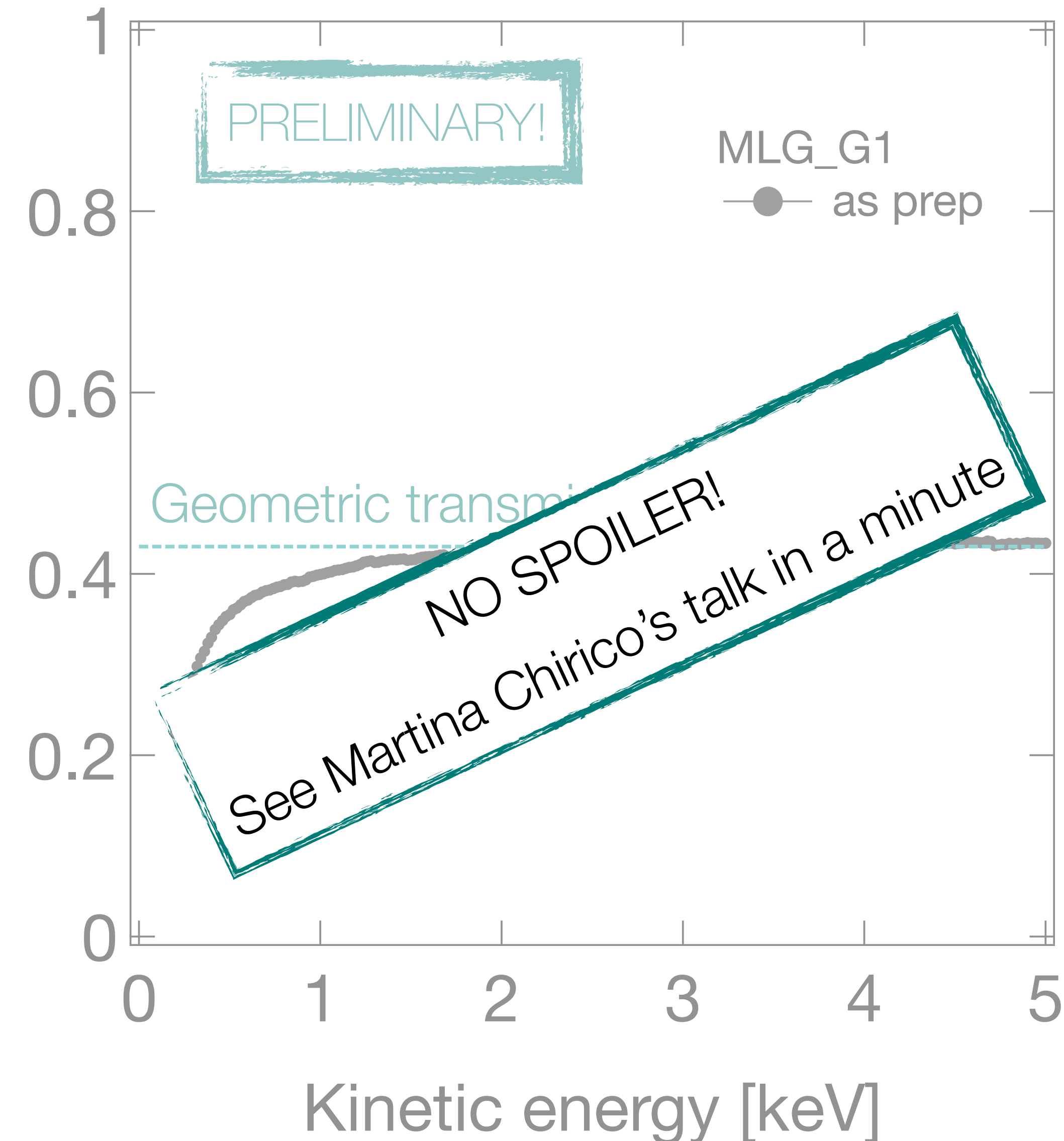
Integrated Transmission Extended Up To 5 keV



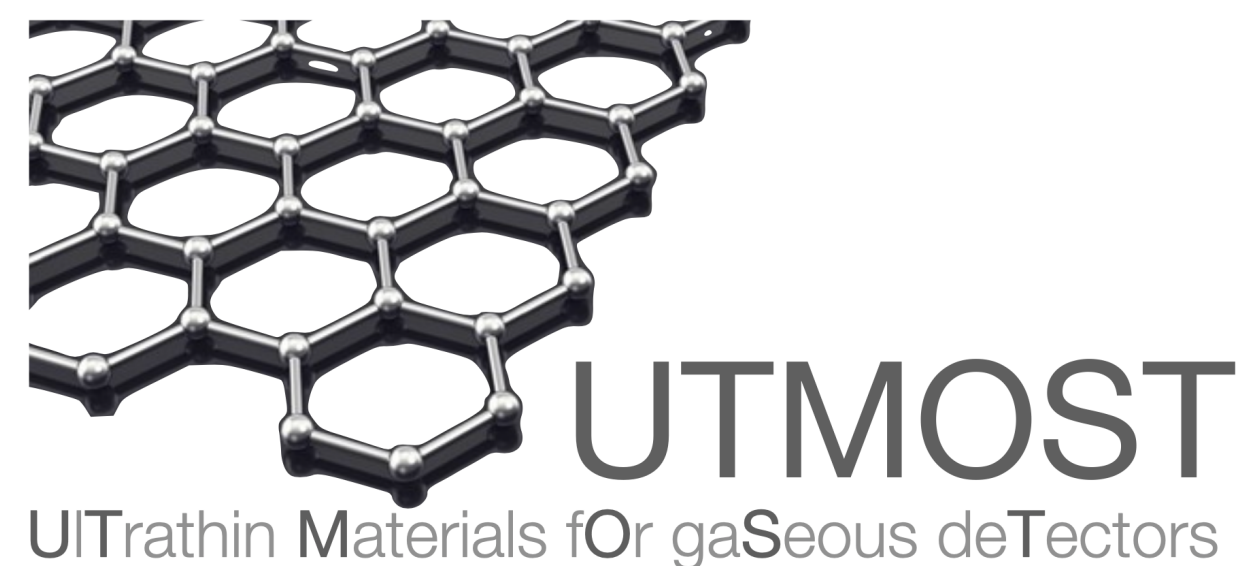
Commercial SPECS e-gun:

- ✿ Continuous electron beam
- ✿ Tuneable energy 0.2 - 5 keV

I_S / I_0

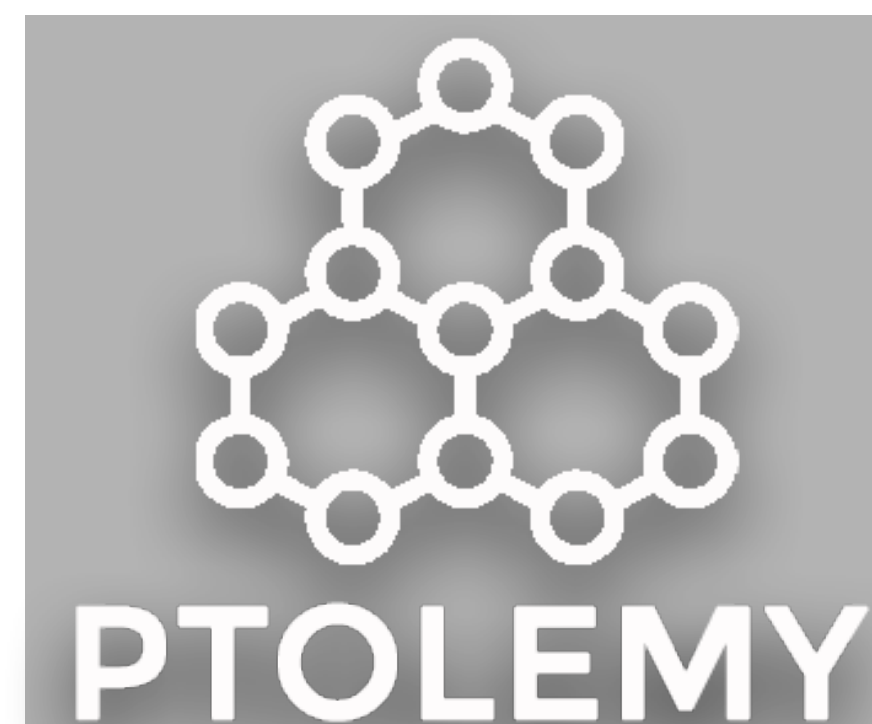
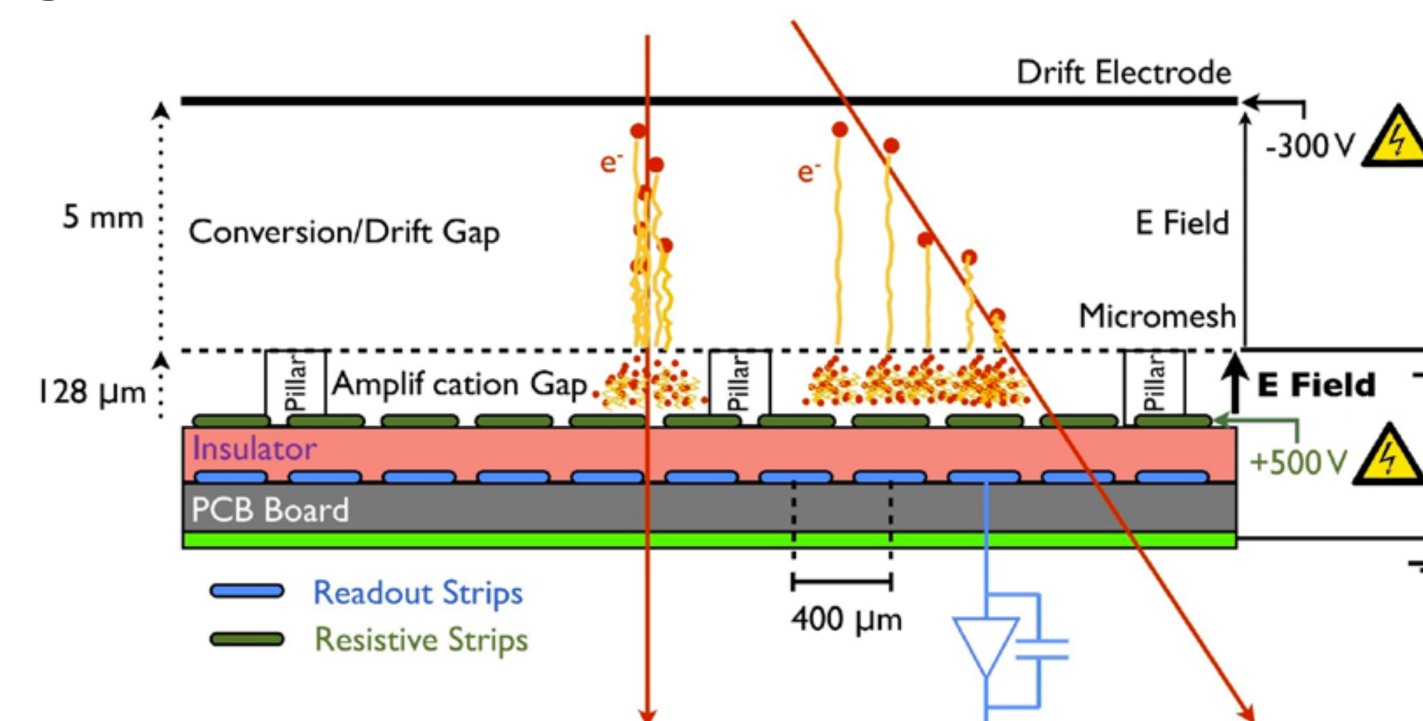


GREENT project will measure the cross-section of electrons-graphene interaction (and any other 2D!)



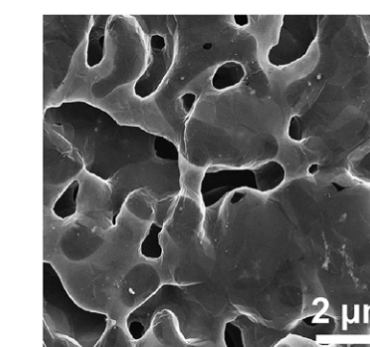
Design gas detectors with highly improved performances:

- ❖ Graphene on the mesh (or GEM)
- ❖ Conversion and avalanche gas(es) optimised in mixture and pressure
- ❖ Ion back-flow prevented

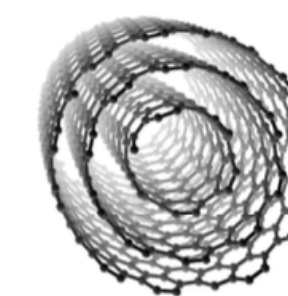


Development of novel neutrino detector PTOLEMY:

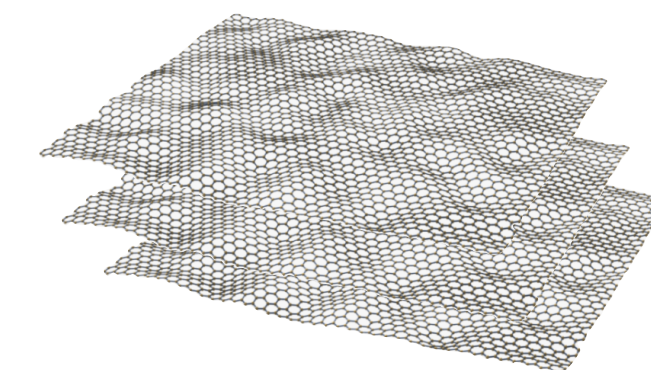
- ❖ Graphene-based target
- ❖ Transmission of electrons (higher energy) is crucial



Nanoporous graphene

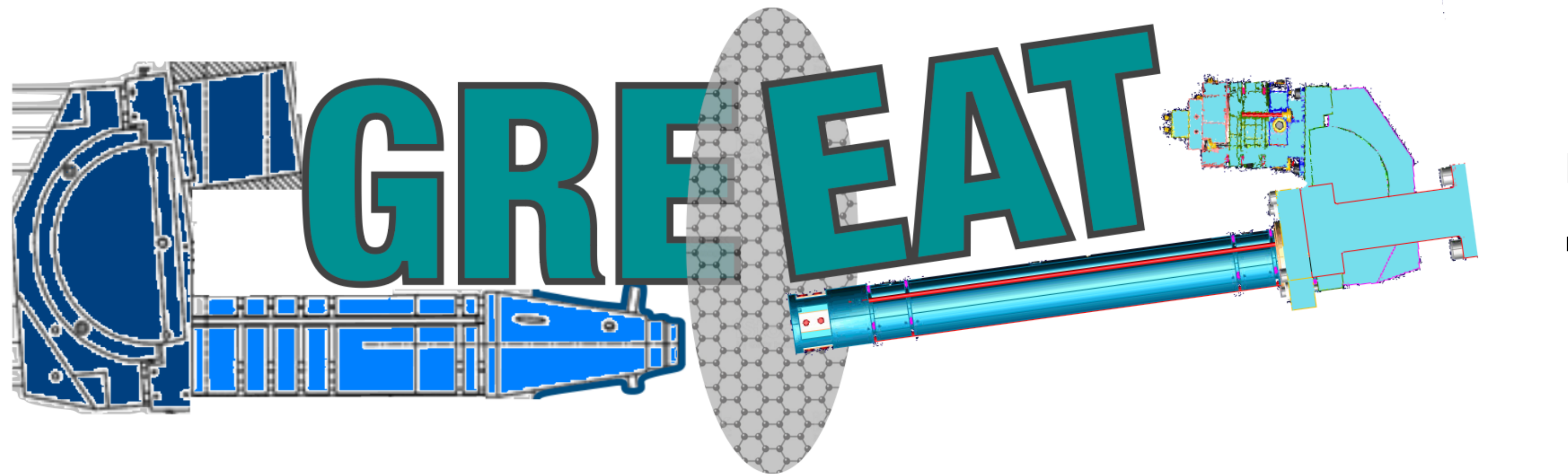


Carbon nanotubes



Stacked graphene

STAY TUNED, IT WILL BE



BACKUP

But How Do You Measure the Cross-Section?

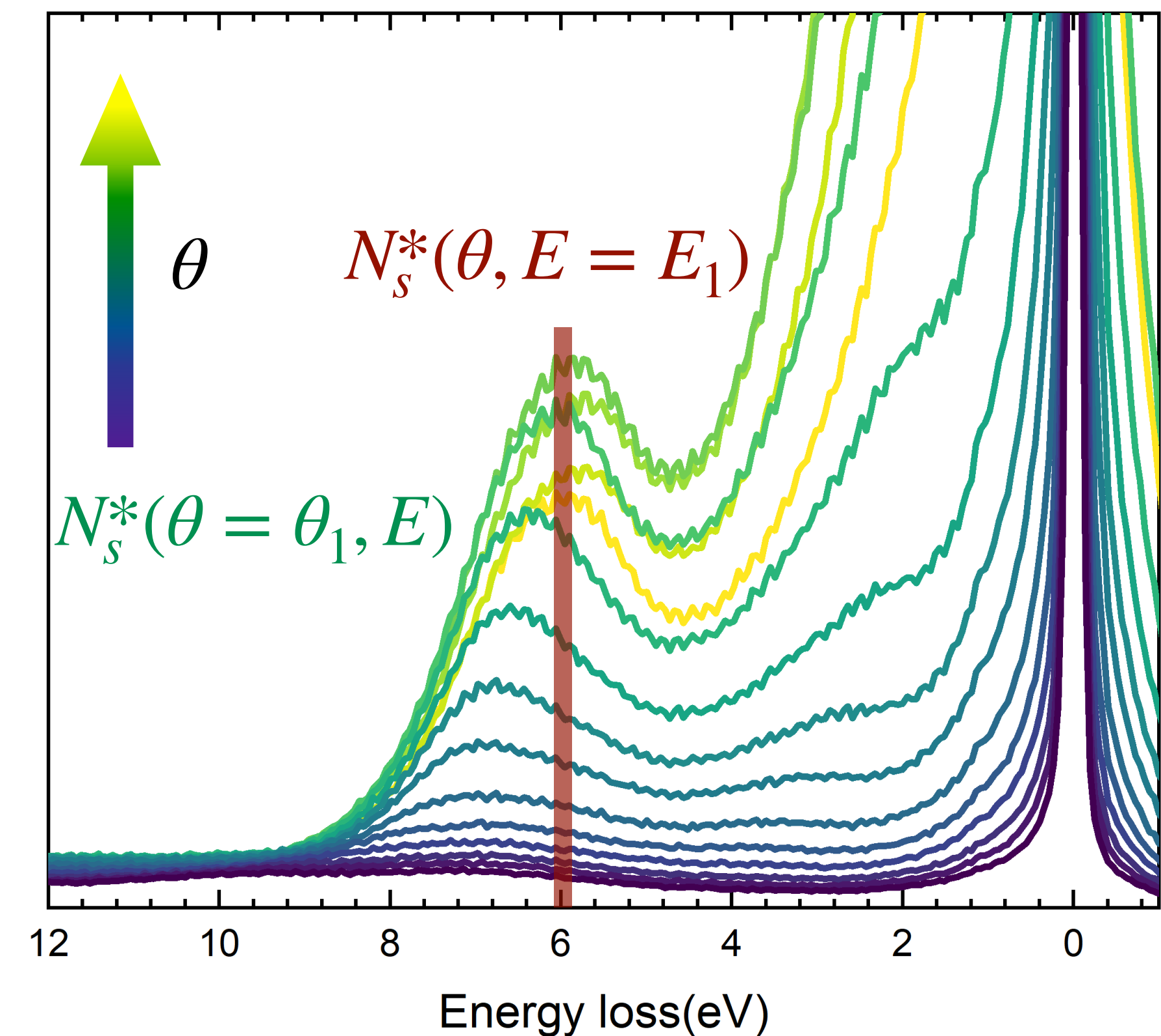
$$\sigma = \frac{N_s}{N_0 n_G}$$

$$n_G \sim 39 \text{ nm}^{-2}$$

Energy loss measurement:

- ❖ Distribution of the transmitted electrons N_s^*
- ❖ Spectrum at a given angle $\rightarrow N_s^*(\theta = \theta_1, E)$
- ❖ Repeat for different angles
- ❖ Slice at a given energy loss $\rightarrow N_s^*(\theta, E = E_1)$
- ❖ Repeat for different primary energies

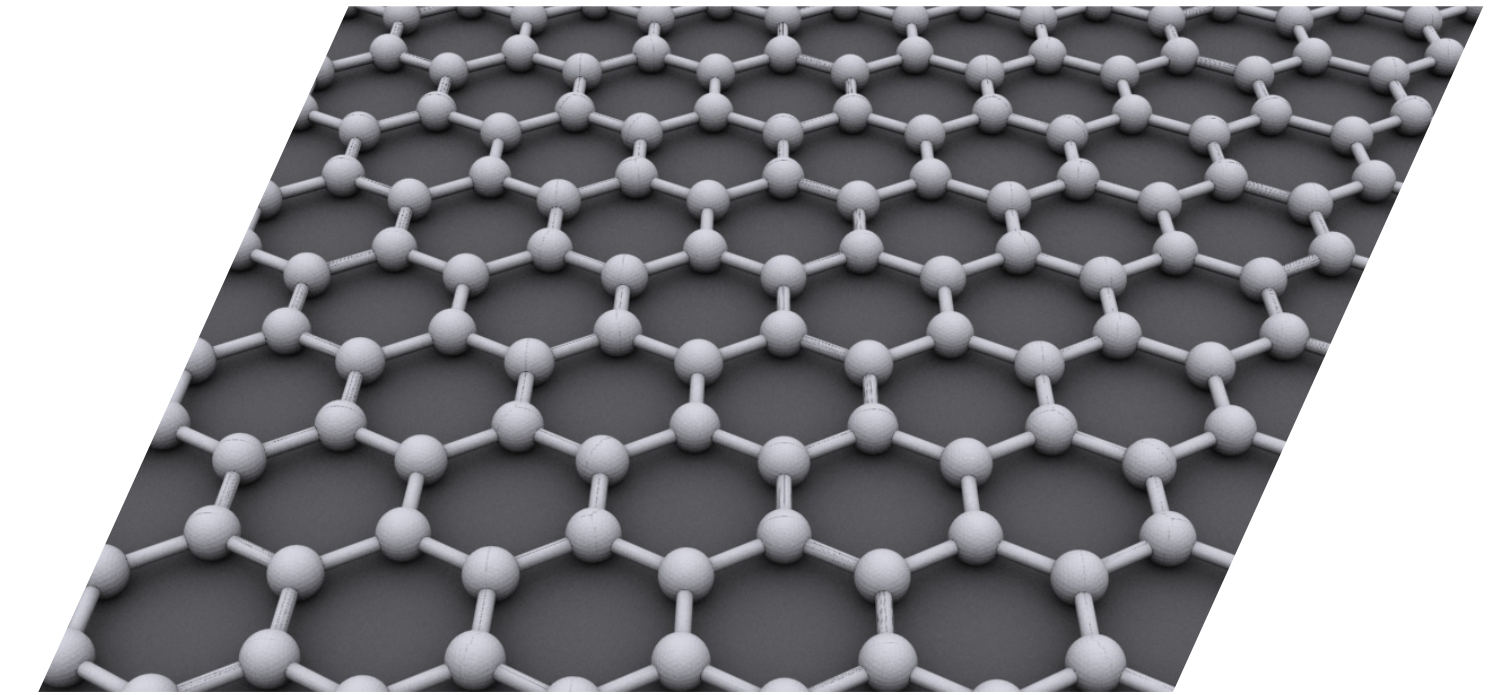
$$N_s^* = N_s \epsilon \text{ (detector efficiency)}$$



Graphene Transparency: a Growing Topic of Interest

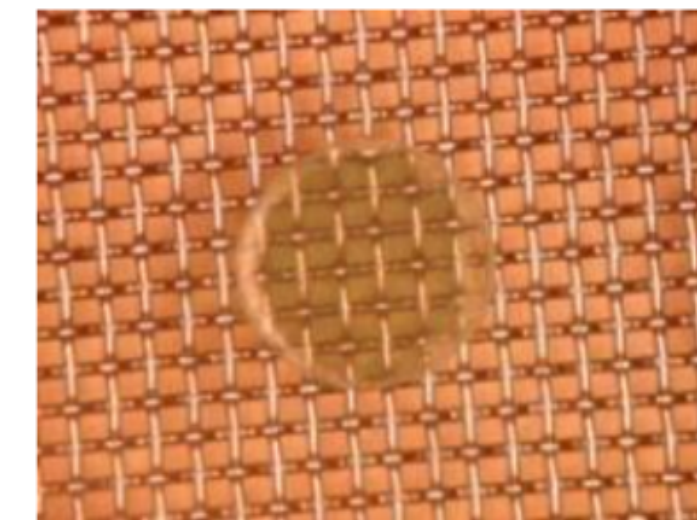
Graphene:

- ❖ Single sheet 1 atom thick
- ❖ C atoms arranged in honeycomb lattice

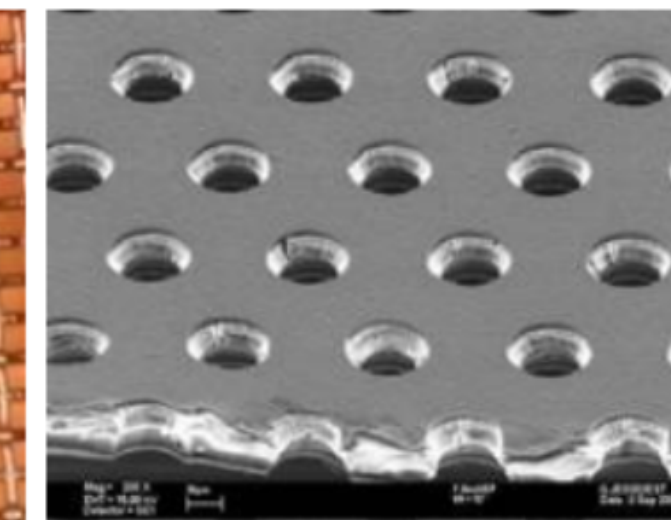


Integration of graphene in **MPGD**:

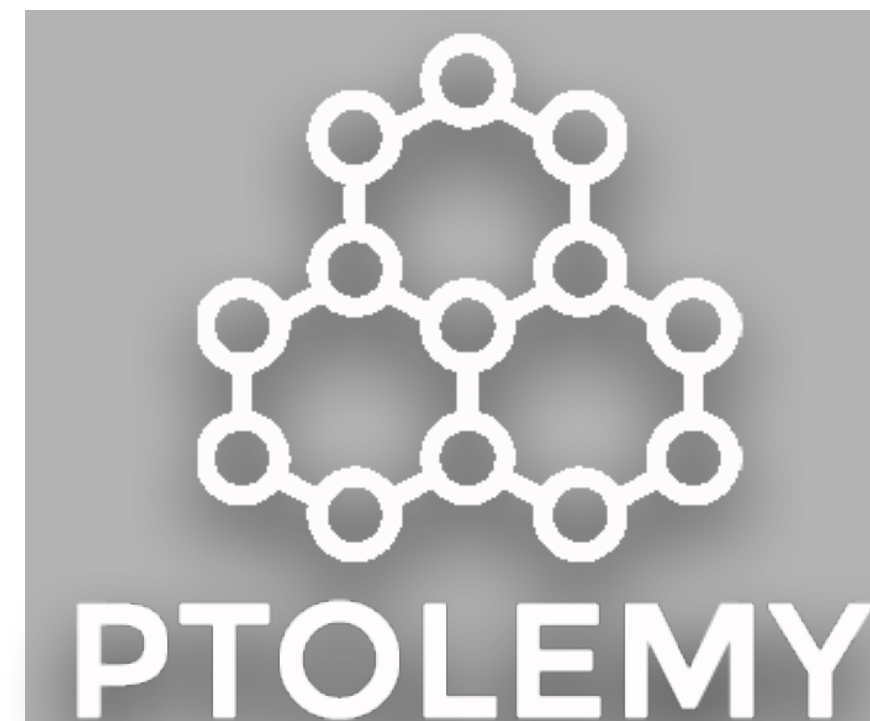
- ❖ Transparency to electrons
- ❖ Impermeability to atoms



MicroMegas



GEM



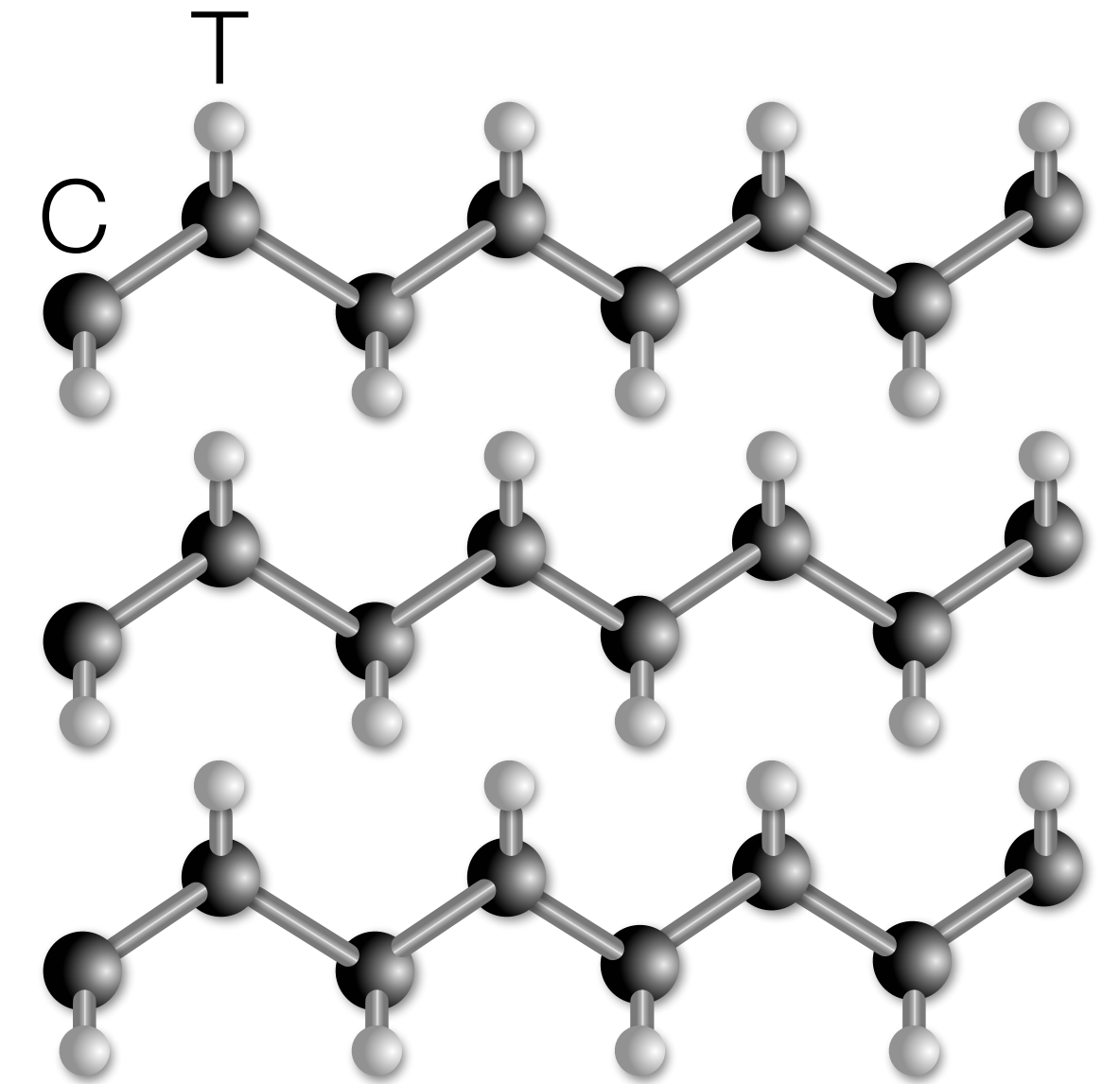
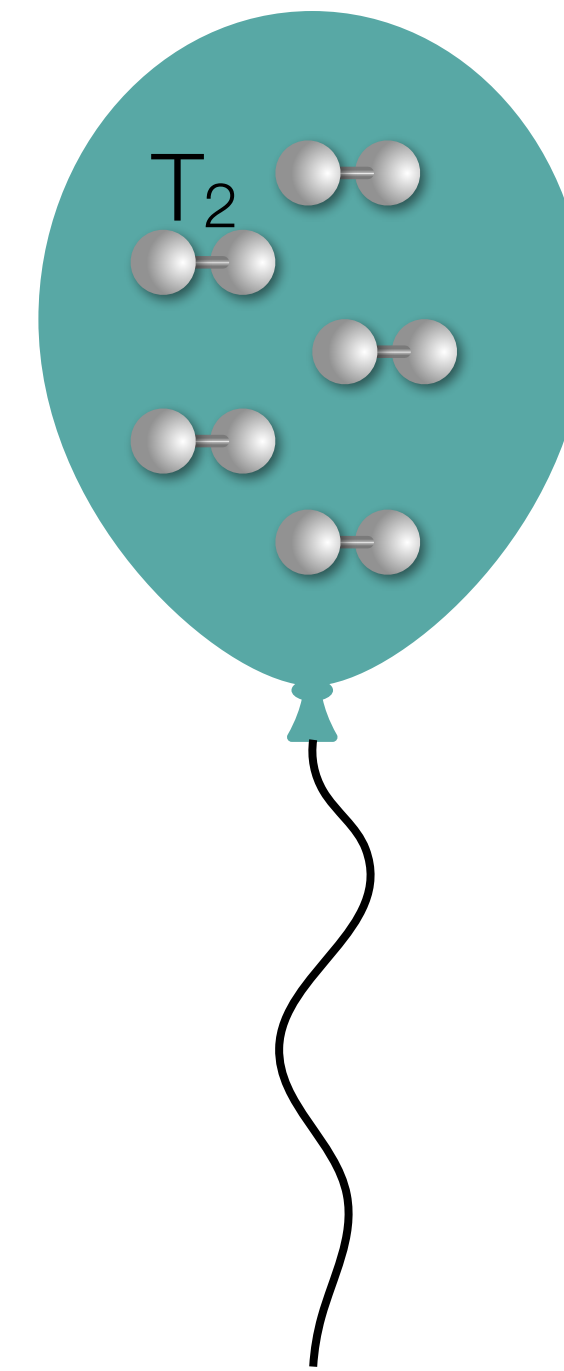
PTOLEMY experiment:

- ❖ Neutrino mass
- ❖ Tritiated **graphene target**

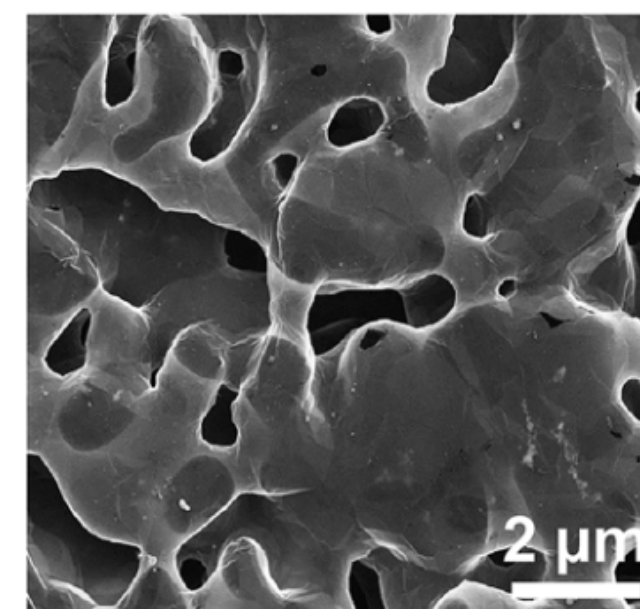
T on Graphene as Ptolemy Target

PTOLEMY experiment:

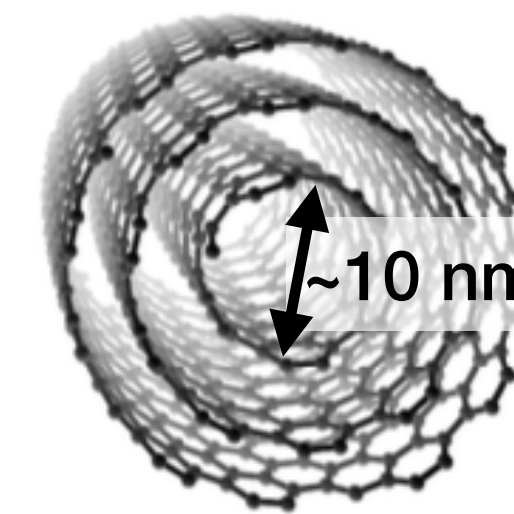
- ❖ Cosmic neutrino background and neutrino mass
- ❖ Measure the β -spectrum at end-point
- ❖ Tritium (T) in a solid-state target
- ❖ Carbon nanostructures main candidates
- ❖ Wrapped/Stacked configurations to improve density



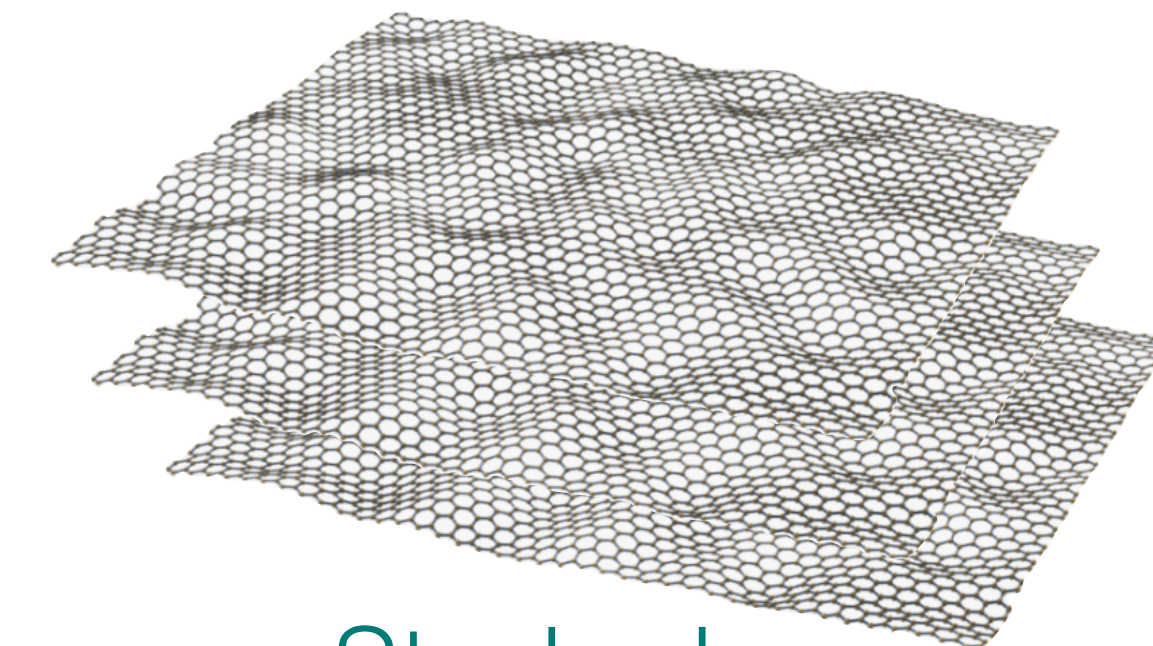
Graphene - electron transmission?



Nanoporous
graphene



Carbon
nanotubes

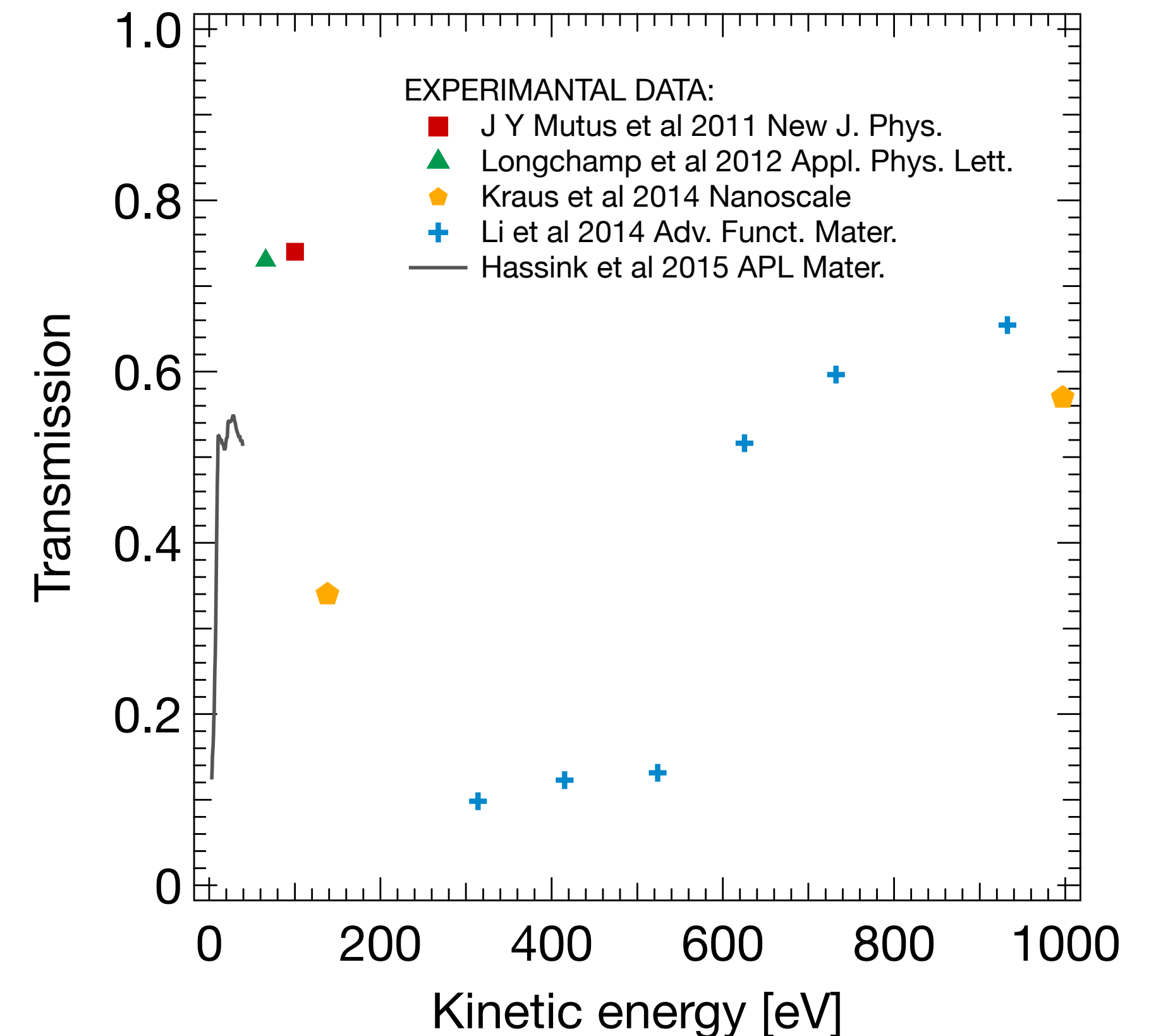


Stacked
graphene

Graphene Transparency: Lots of Interest But Lack of Information

Transmission of low-energy electrons through graphene:

- ✿ Only a few data **below 1 keV**
- ✿ Clear **lack** of information
- ✿ **Cross-section**: still unknown



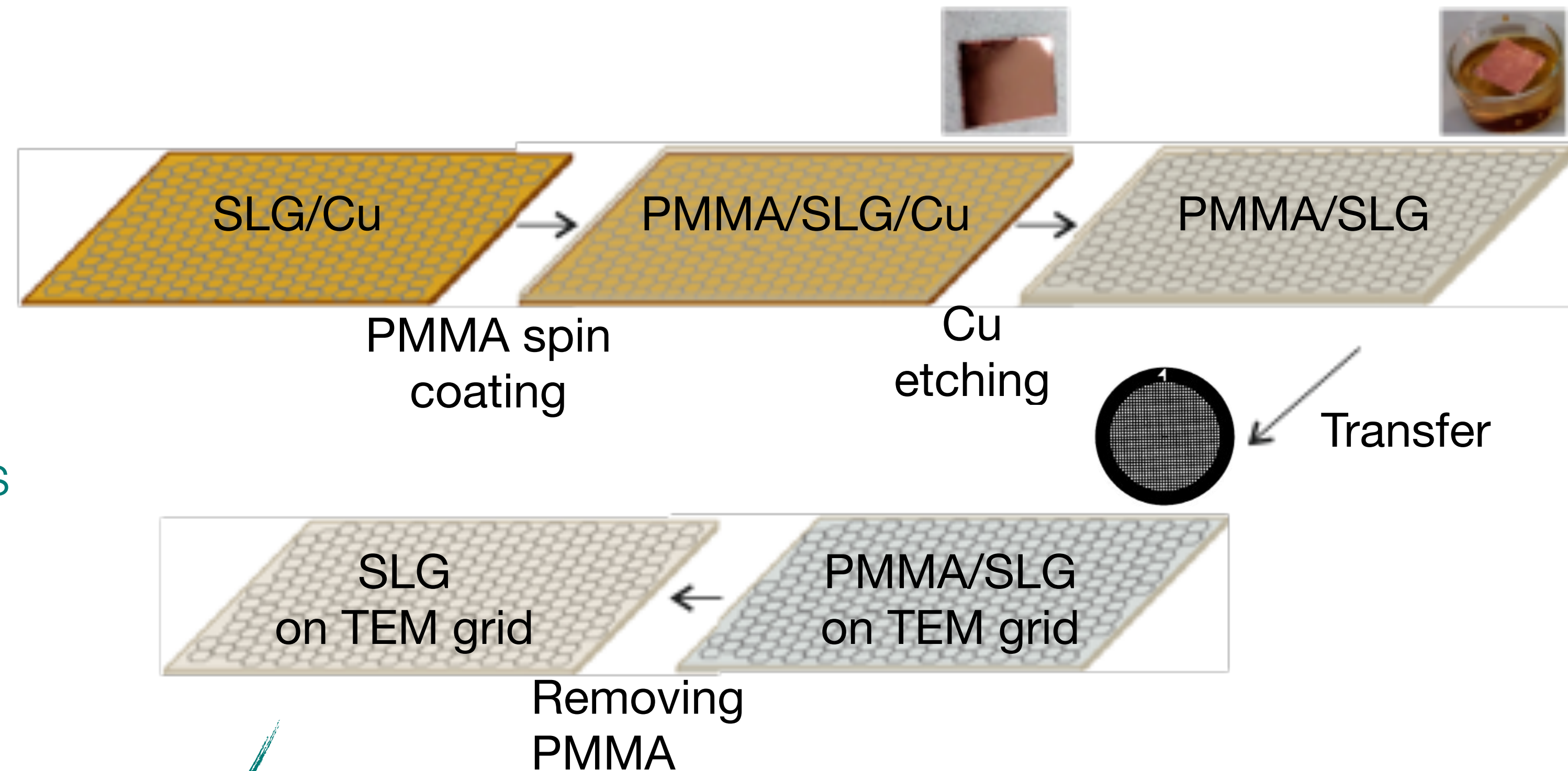
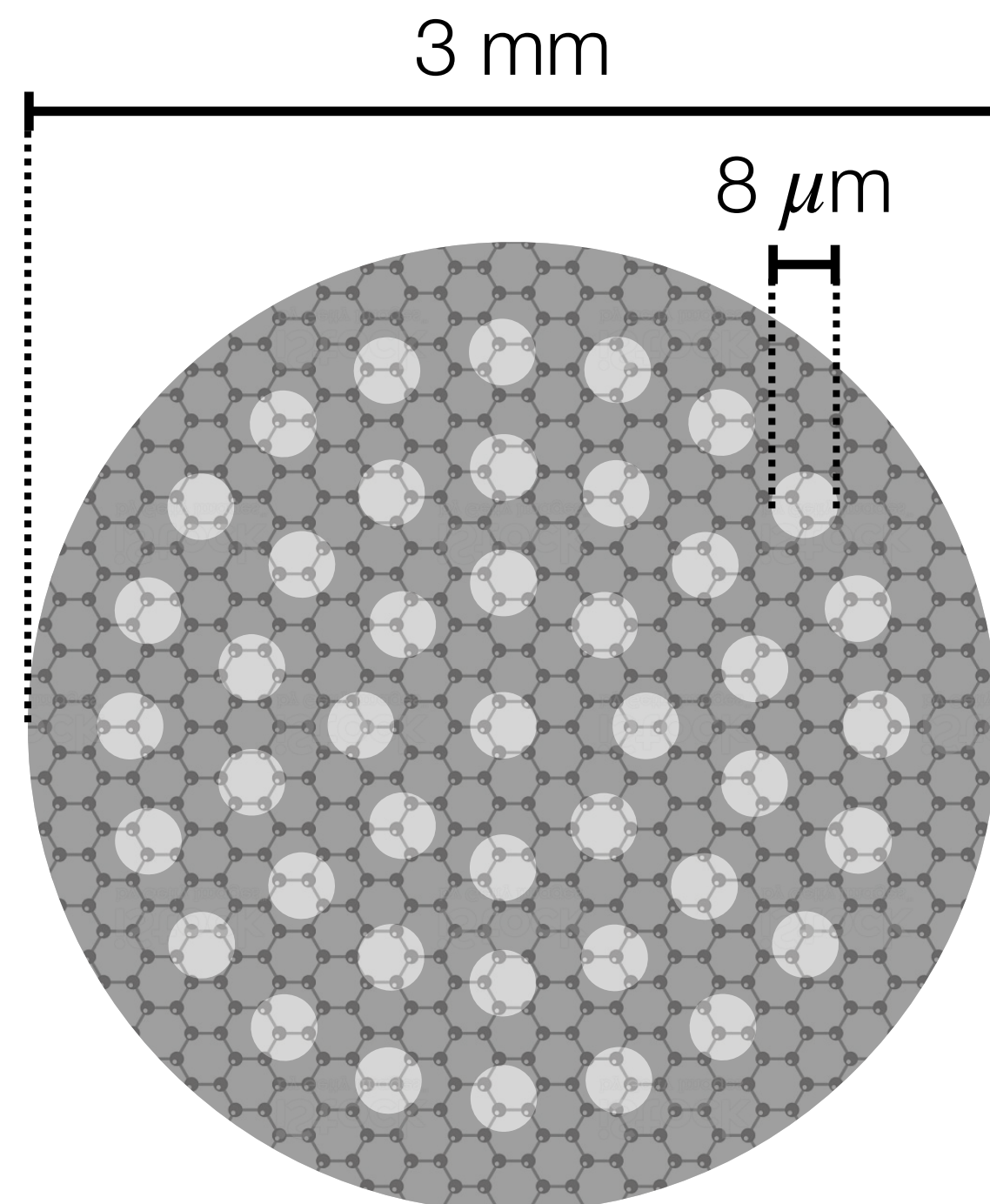
Our work included so far:

- ✿ Graphene thorough **characterisation**
- ✿ **Transmission** measurement in an **extended energy range (30 - 900 eV)**

Our Samples: Graphene Transferred Onto Metallic Grids

Monolayer graphene on nickel grids:

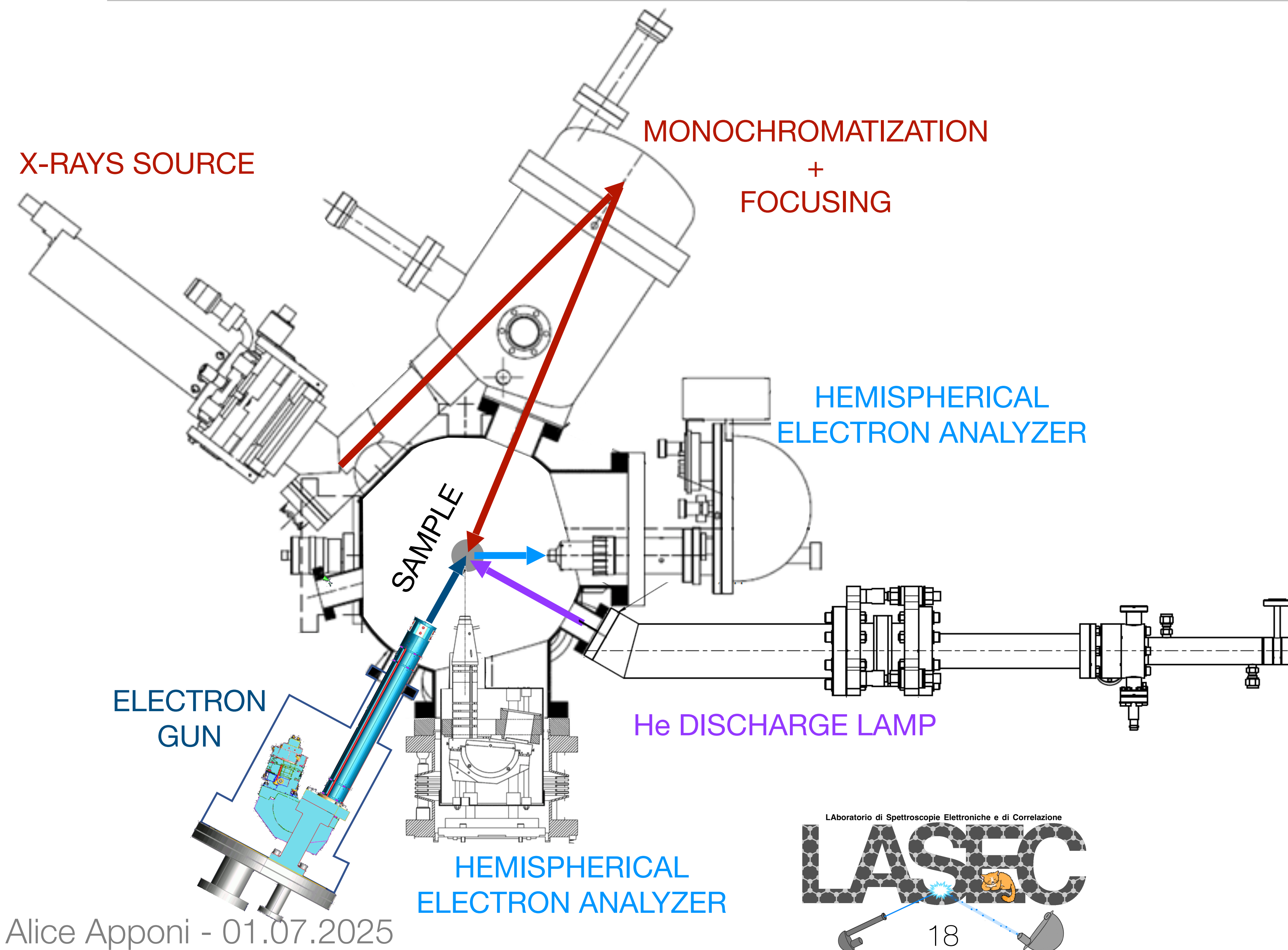
- ❖ Graphene grown on copper
- ❖ Transfer onto commercial nickel grids (Ted Pella Inc. - G2000HAN)
- ❖ Access to suspended graphene regions



A. Apponi et al., Carbon (2024),
<https://doi.org/10.1016/j.carbon.2023.118502>



UITrathin Materials fOr gaSeous deTectors
PTOLEMY General Meeting - Nijmegen



X-ray Al $K\alpha$ source:

- ❖ $h\nu = 1486.7$ eV
- ❖ Monochromatized beam
- ❖ XPS resolution = 0.46 eV

Custom-made monochromatic electron gun:

- ❖ Continuous electron beam
- ❖ Tuneable energy 30 - 900 eV
- ❖ Resolution = 45 meV

He discharge lamp:

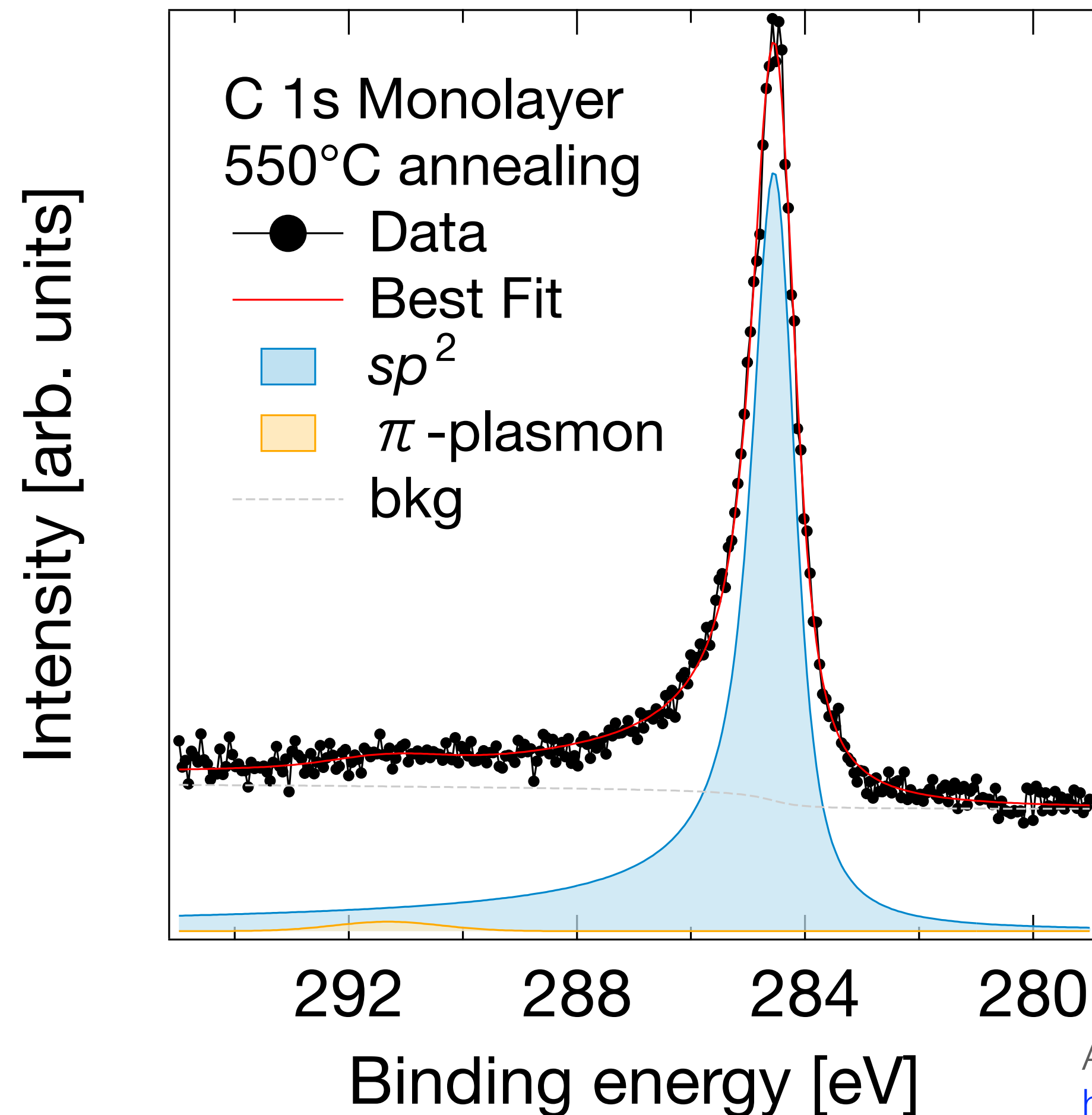
- ❖ Spot diameter 300 μm

Spectroscopic Characterisation Reveals High Quality Graphene

X-ray photoemission spectroscopy (XPS):

✦ C 1s core-level spectrum

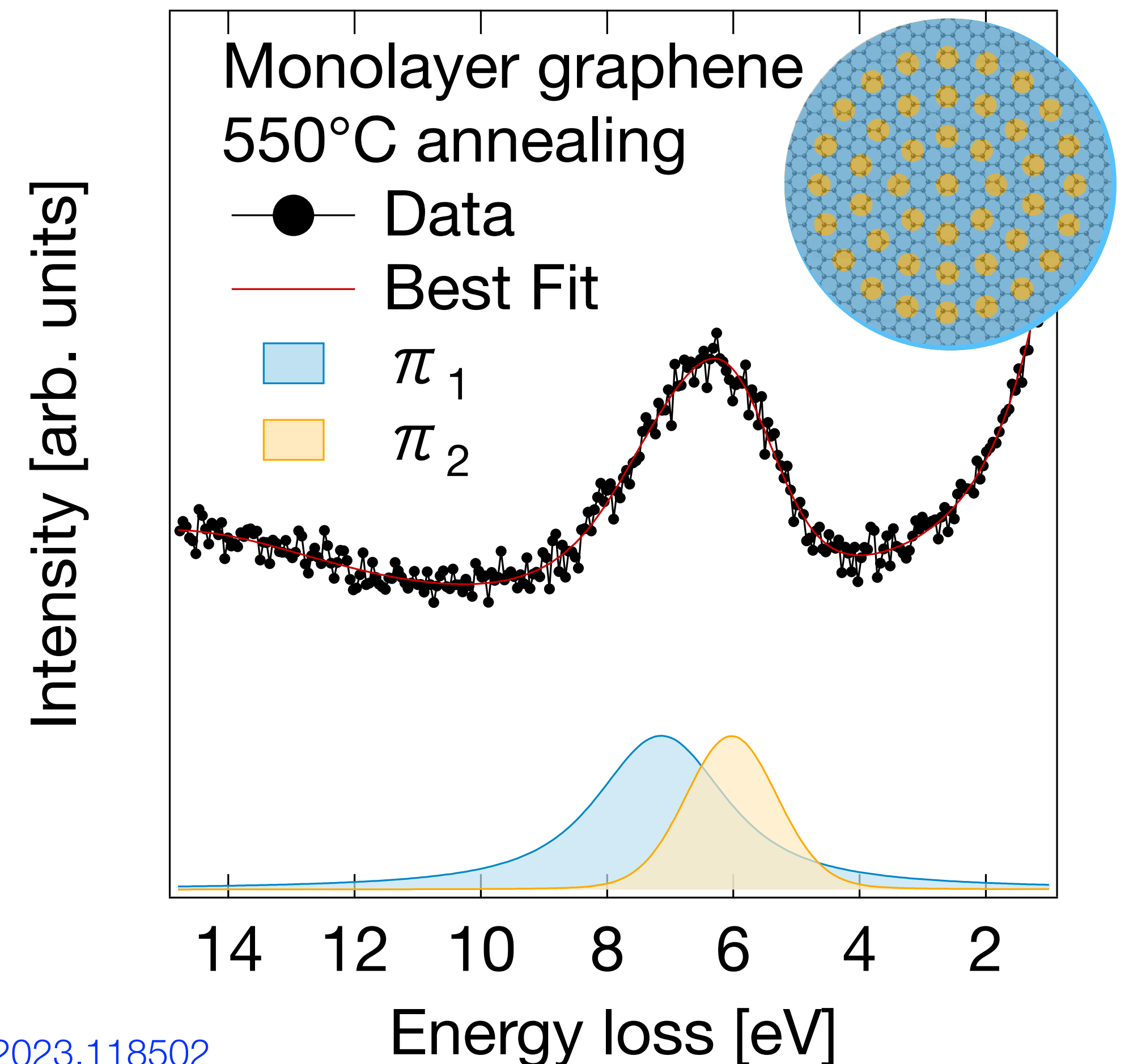
✦ Pure sp^2 contribution $\rightarrow$ **high quality** + **cleannes!**



Electron energy loss spectroscopy (EELS):

✦ π -plasmon excitation

✦ **High quality** + **suspended footprint**



A. Apponi et al., Carbon (2024),
<https://doi.org/10.1016/j.carbon.2023.118502>

Greyscale Histogram for the Evaluation of Holes Coverage

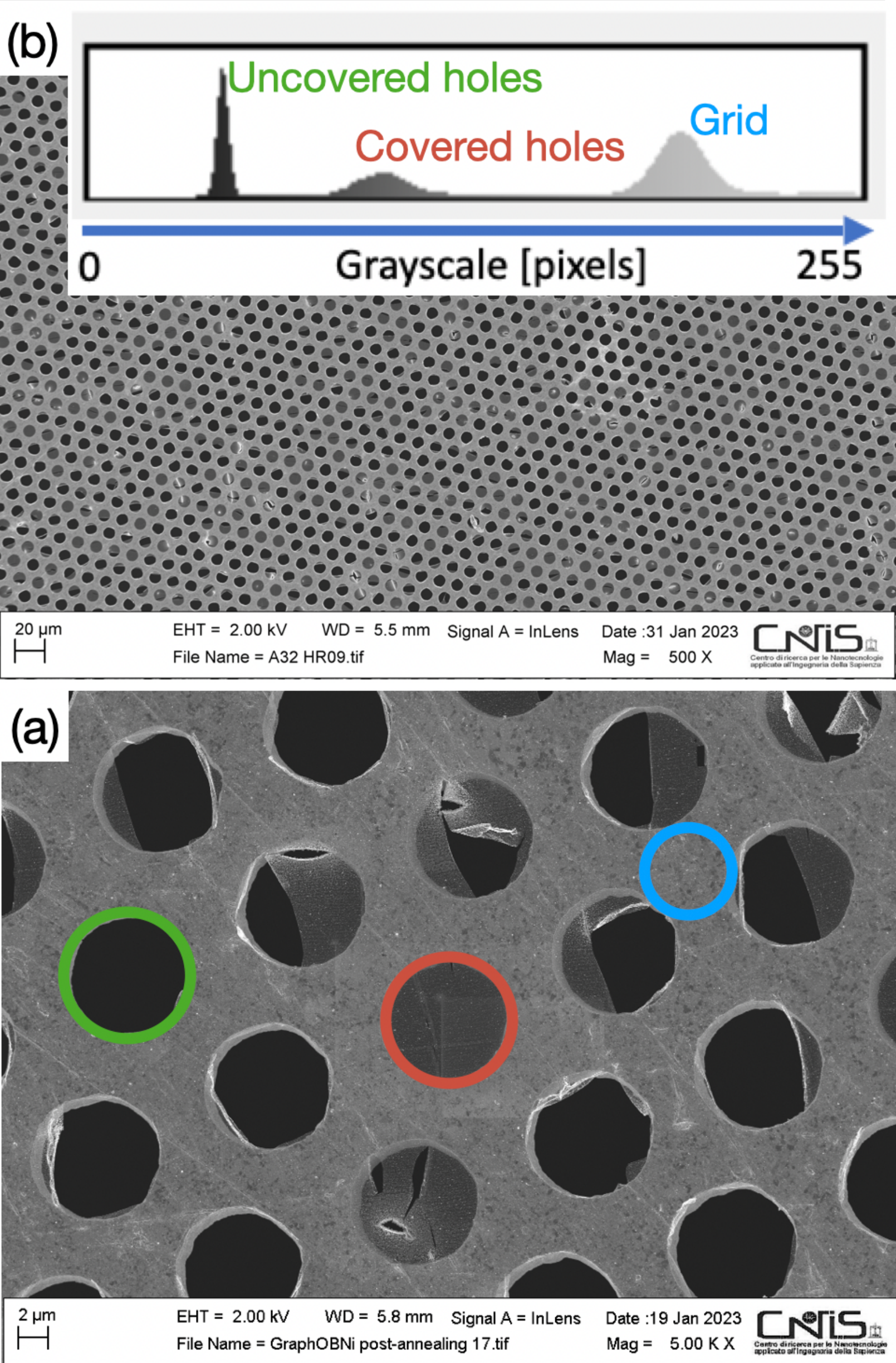
- ❖ Software generates **histogram** based on pixels **grey level**
- ❖ Area of the **covered** holes, **uncovered** holes and **grid** regions
- ❖ Evaluate **graphene coverage** and **geometrical transmission**

Grid **geometrical transmission**

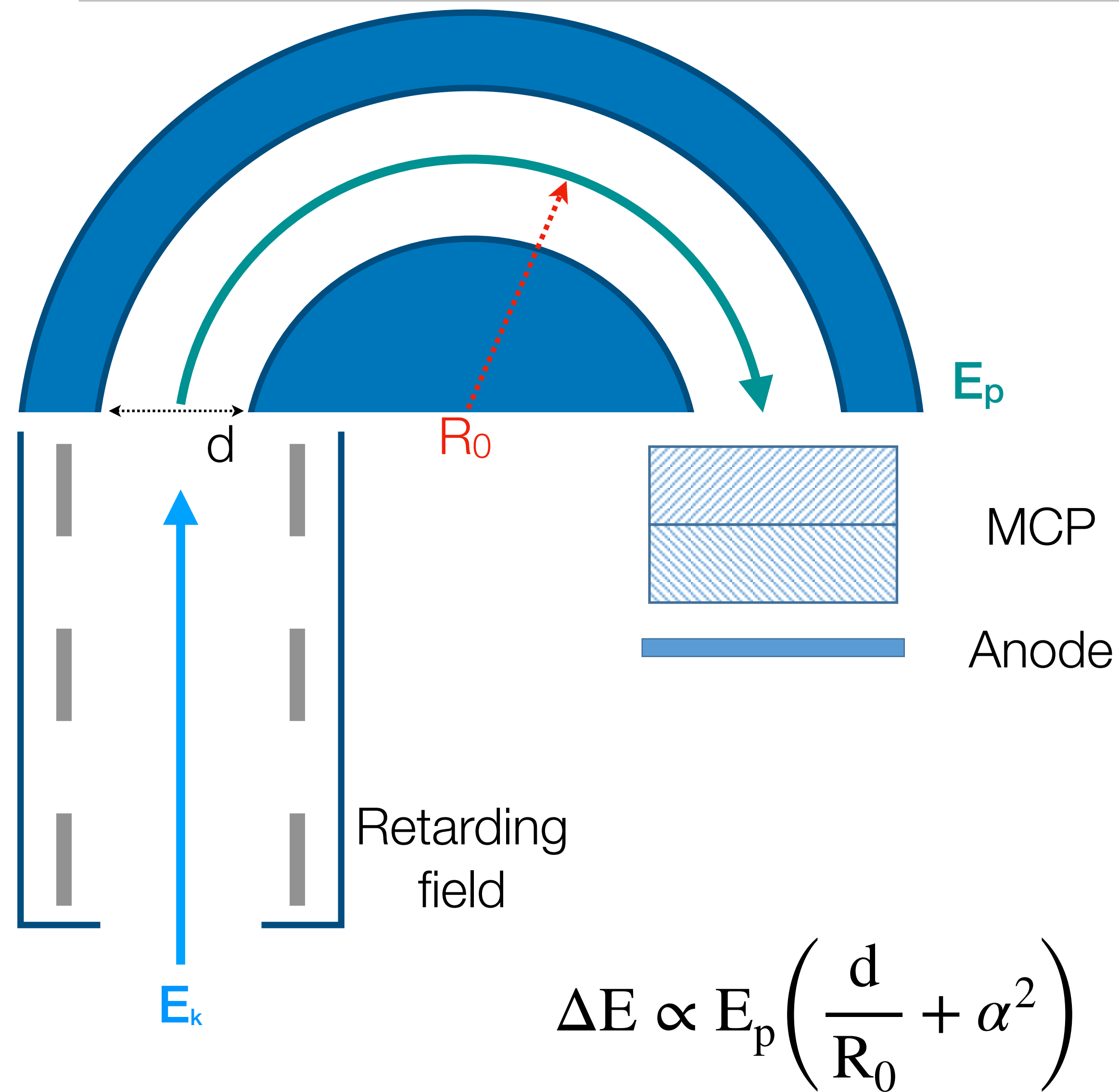
- ❖ Sample A $(37 \pm 1)\%$
- ❖ Sample B $(44 \pm 1)\%$

Graphene **coverage**

- ❖ Sample A $(38 \pm 1)\%$
- ❖ Sample B $(42 \pm 1)\%$



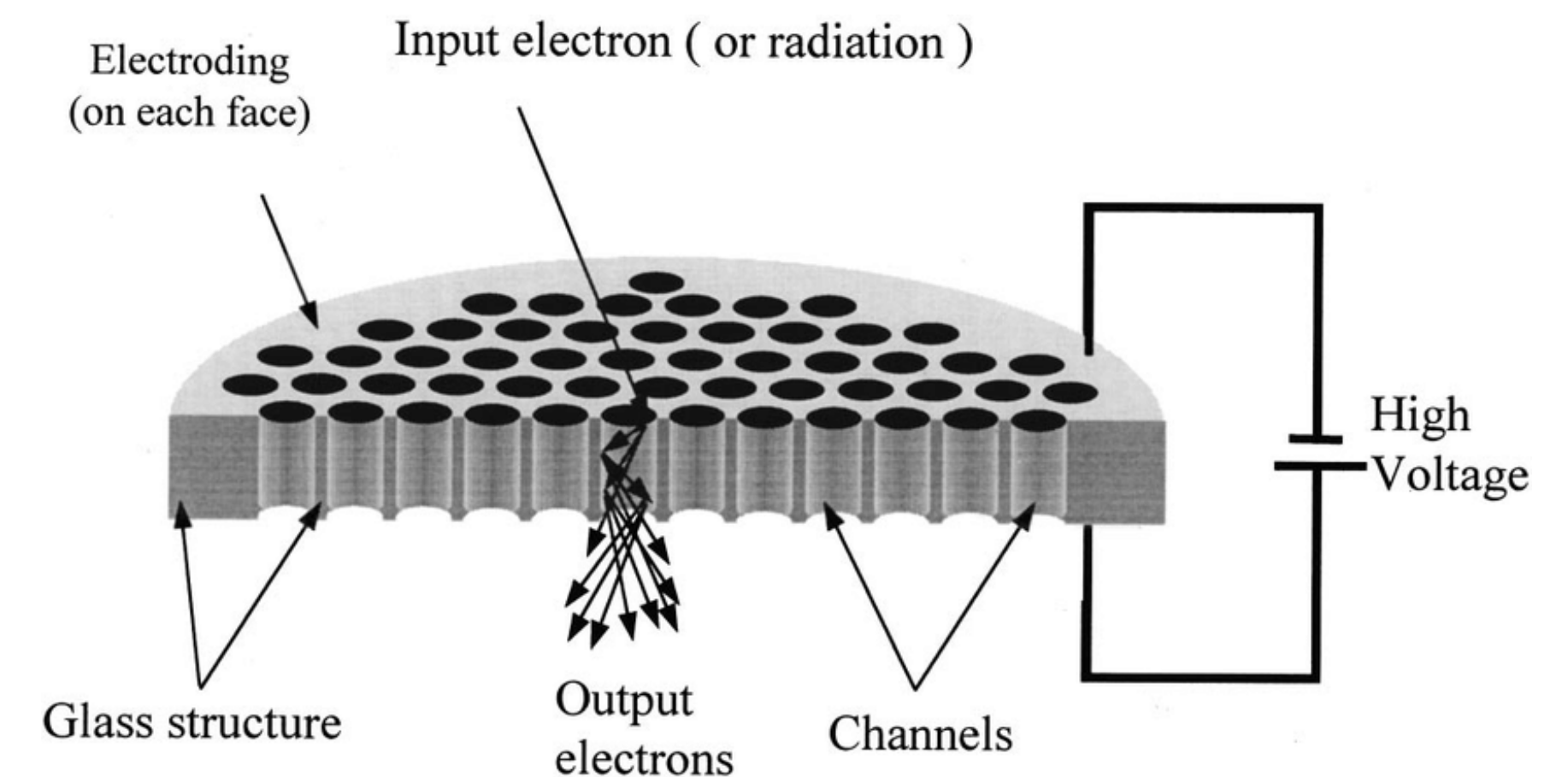
Hemispherical Electron Analyser: an Electrostatic Filter for Electrons



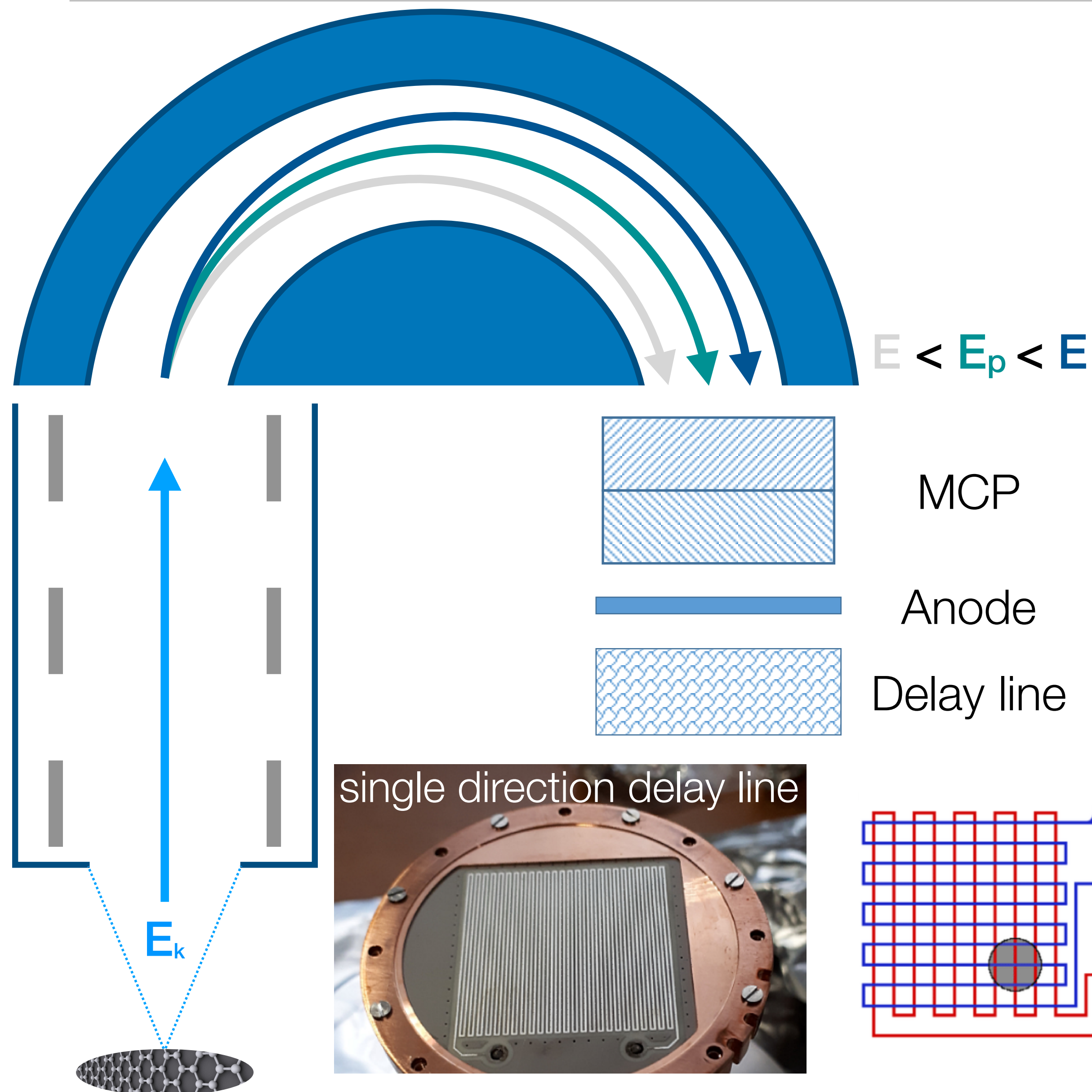
Hemispherical electron analyser:

- ❖ Electrostatic filter
- ❖ Electron detector at exit

Channeltron / microchannel plate (MCP)



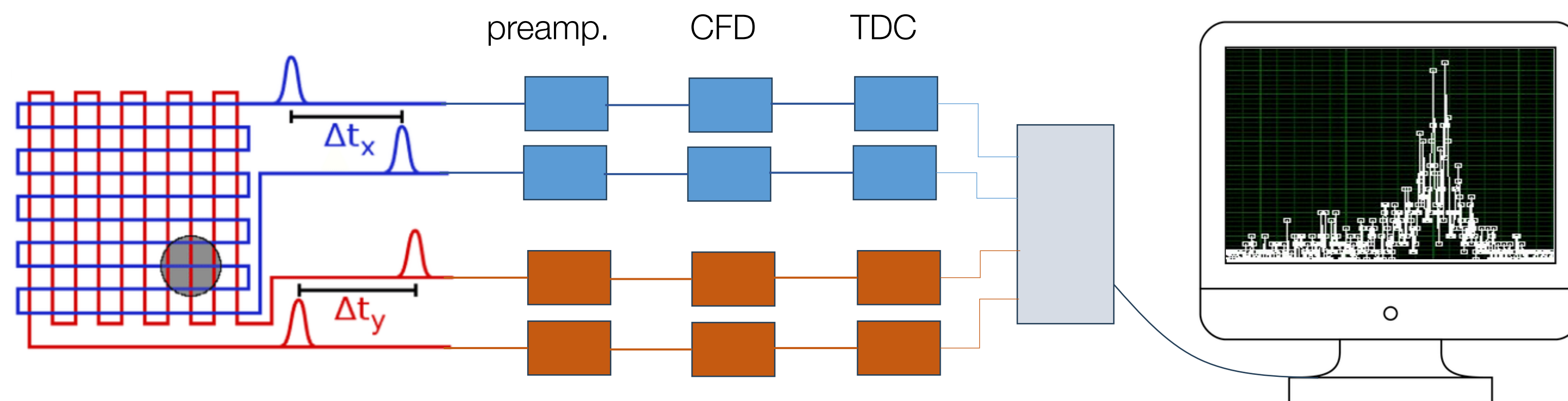
Hemispherical Electron Analyser: an Electrostatic Filter for Electrons



Hemispherical electron analyser:

- ❖ Electrostatic filter
- ❖ Channeltron at exit
- ❖ Final electron position $\propto$ its energy

MCP+Delay line for parallel counting can be implemented

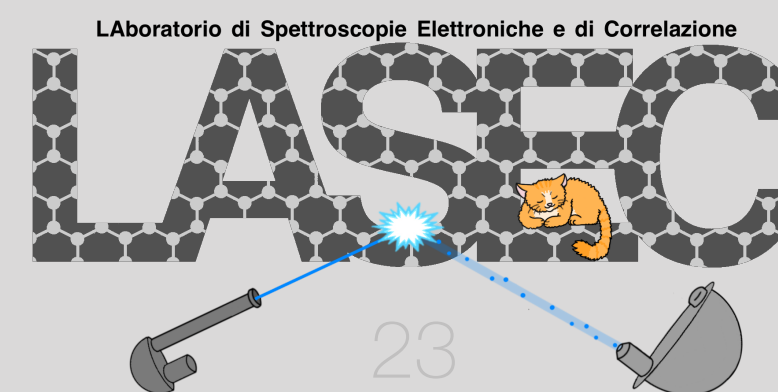


HEMISPHERICAL
ELECTRON ANALYZER

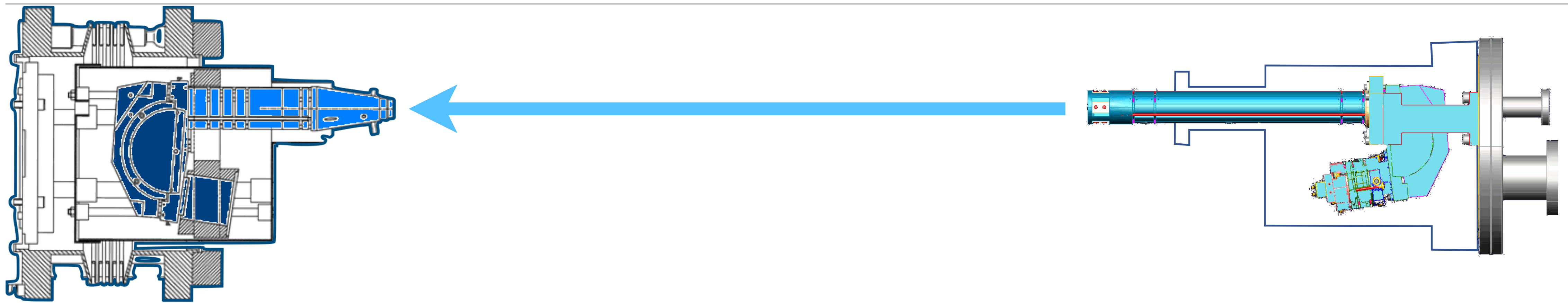
Equipped with position sensitive
detector for parallel acquisition

HEMISPHERICAL
ELECTRON ANALYZER

“Twin” analyzer of the one we
will use in the new chamber



Run the Experiment Backwards: Electron Currents of 10 - 100 fA



Electron **detector** side:

- ❖ Max rate ~ 600 kHz (~ 100 fA) for **linear-mode** operation
- ❖ **Absolute efficiency** of MCP measured with LASEC apparatus

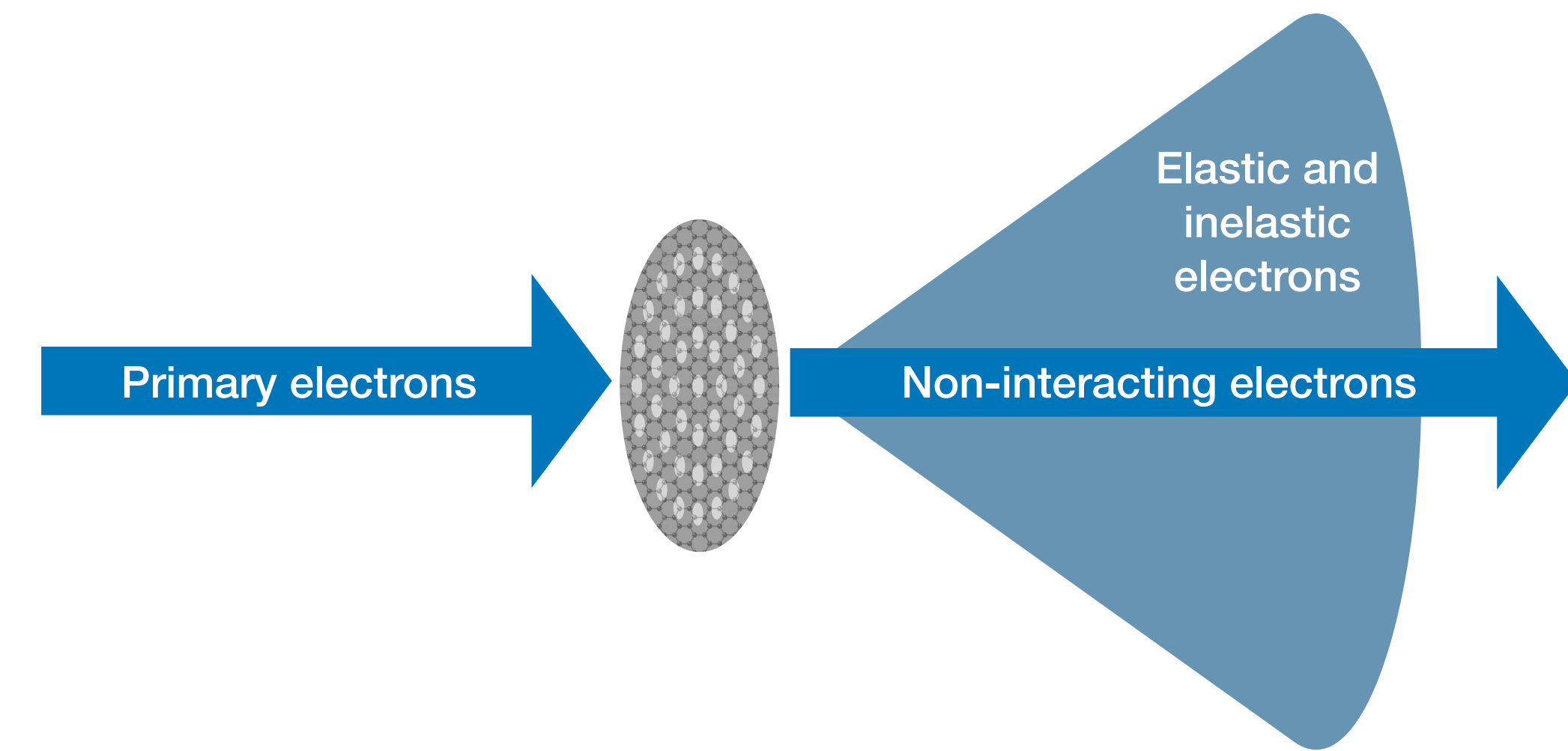
A. Apponi et al., Measur.Sci.Tech (2022), [10.1088/1361-6501/ac3d07](https://doi.org/10.1088/1361-6501/ac3d07)

Monochromatic electron **gun**:

- ❖ Continuous beam ~ 1 fA - ~ 40 nA
- ❖ Tuneable energy within **30 - 900 eV**
- ❖ **Optimal stability** even down to a few fA

We will run the experiments with **electron currents** in the **10 - 100 fA** range

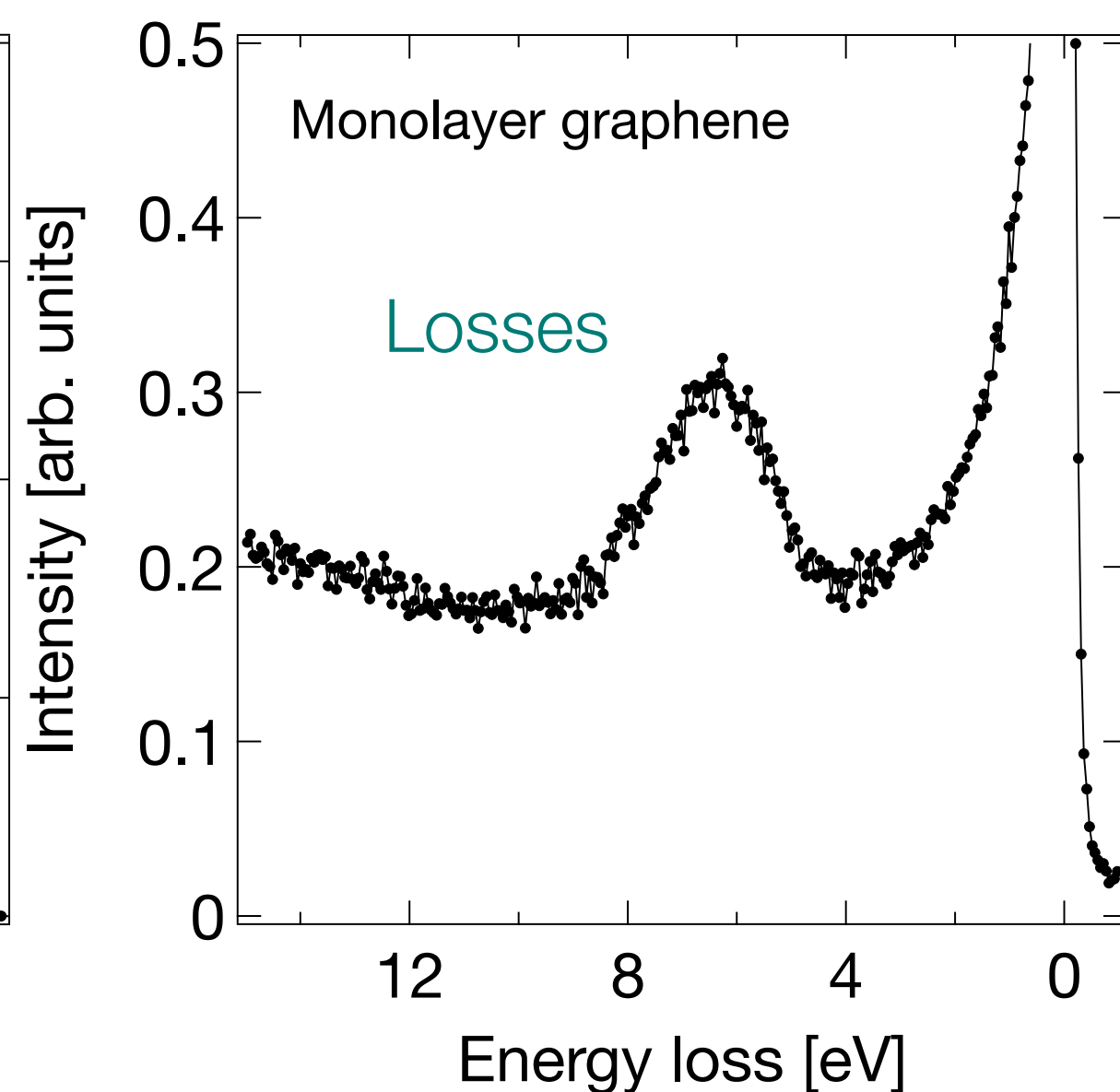
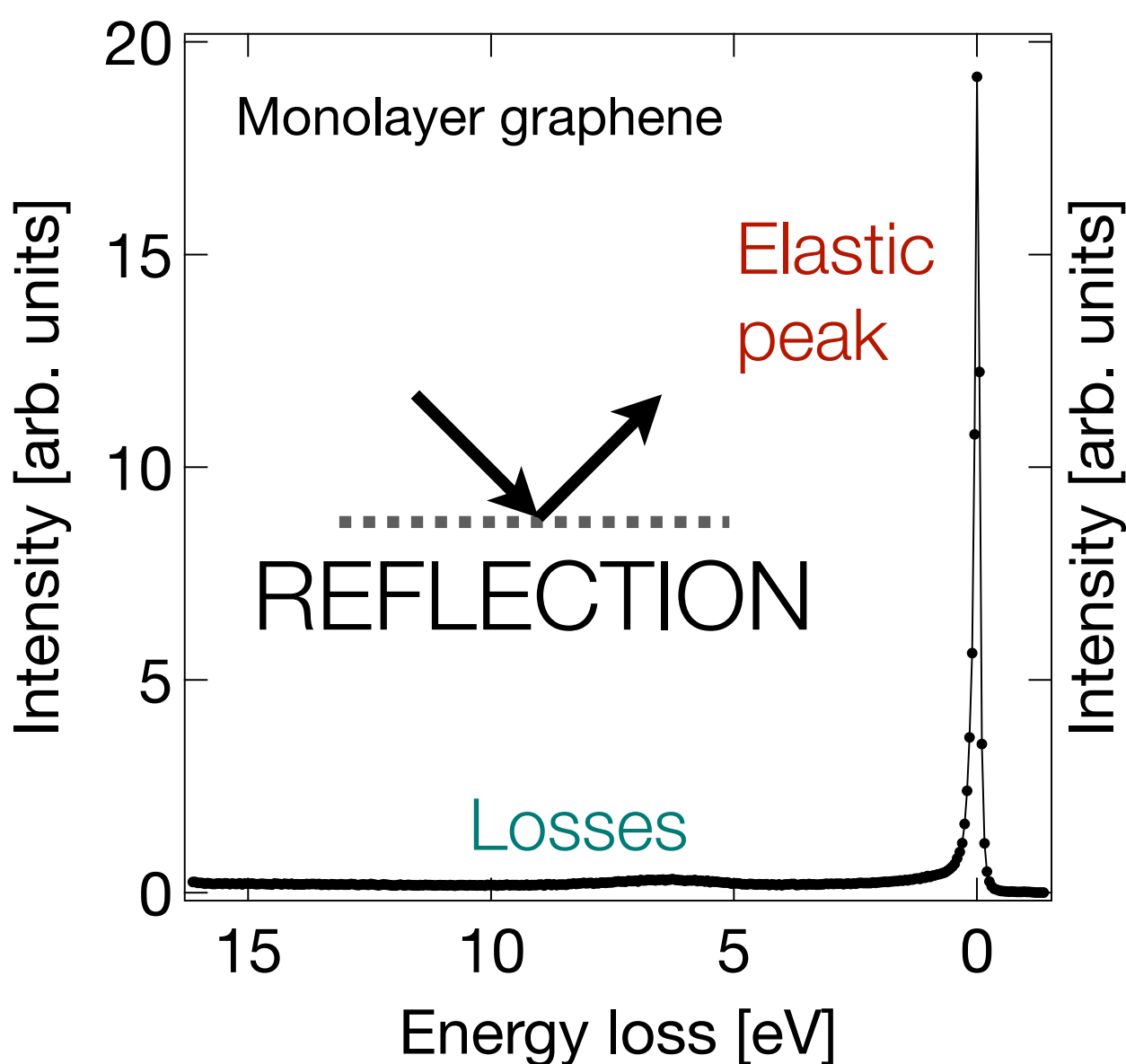
Start with Non-Interacting e⁻, Boost with Parallel Acquisition for Scattered e⁻



Non-interacting electrons:

- ✿ Measure at “0 angle” (1° angular acceptance)
- ✿ Total cross-section

I year goal

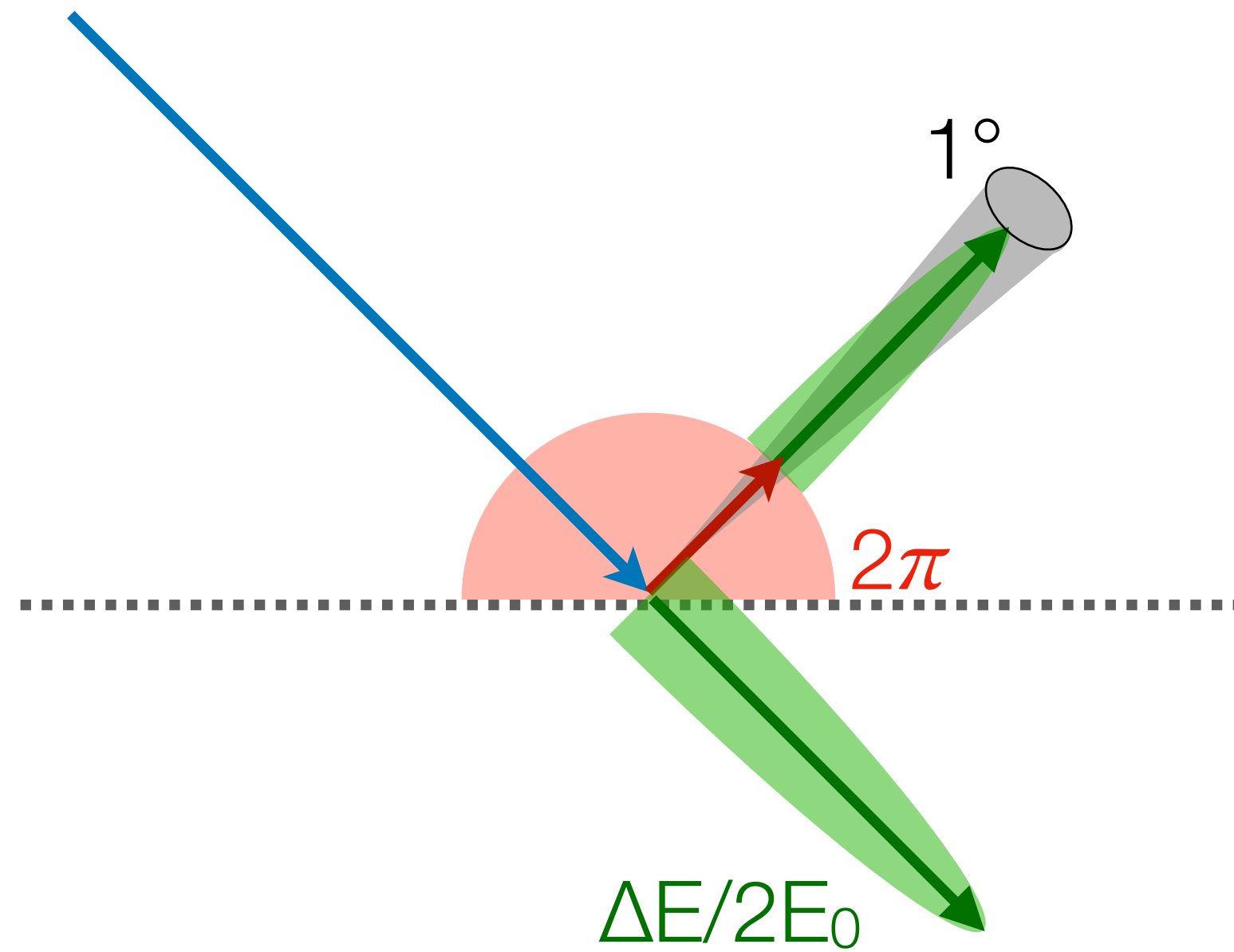


Scattered electrons:

- ✿ Reflection spectrum acquired in 30 hours with channeltron
- ✿ MCP+delay line for parallel acquisition gives a (vital) 10x boost
- ✿ Similar acquisition time in transmission
- ✿ Differential and total cross-section

II year goal

Reflection vs Transmission signal



REFLECTION PROCESS: EL+ANEL

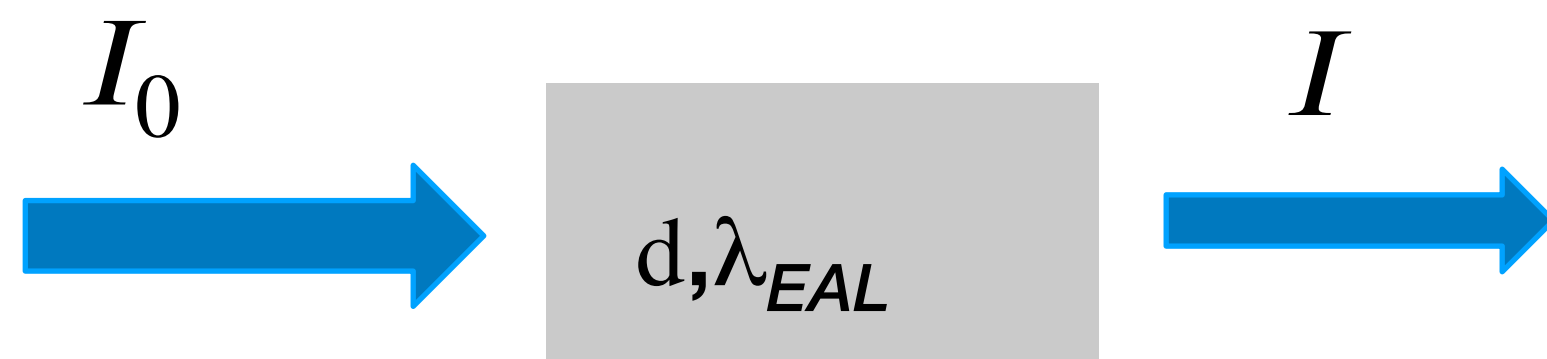
Electrons accepted within analyser

$$\frac{(0.5/57)^2 \pi}{2\pi} \sim 4 \times 10^{-5}$$

TRANSMISSION PROCESS: ANEL

$$\text{TRANSMISSION} = 4 \times 10^5 \times \text{REFLECTION}$$

Thickness of a 2D material is an ill-defined quantity

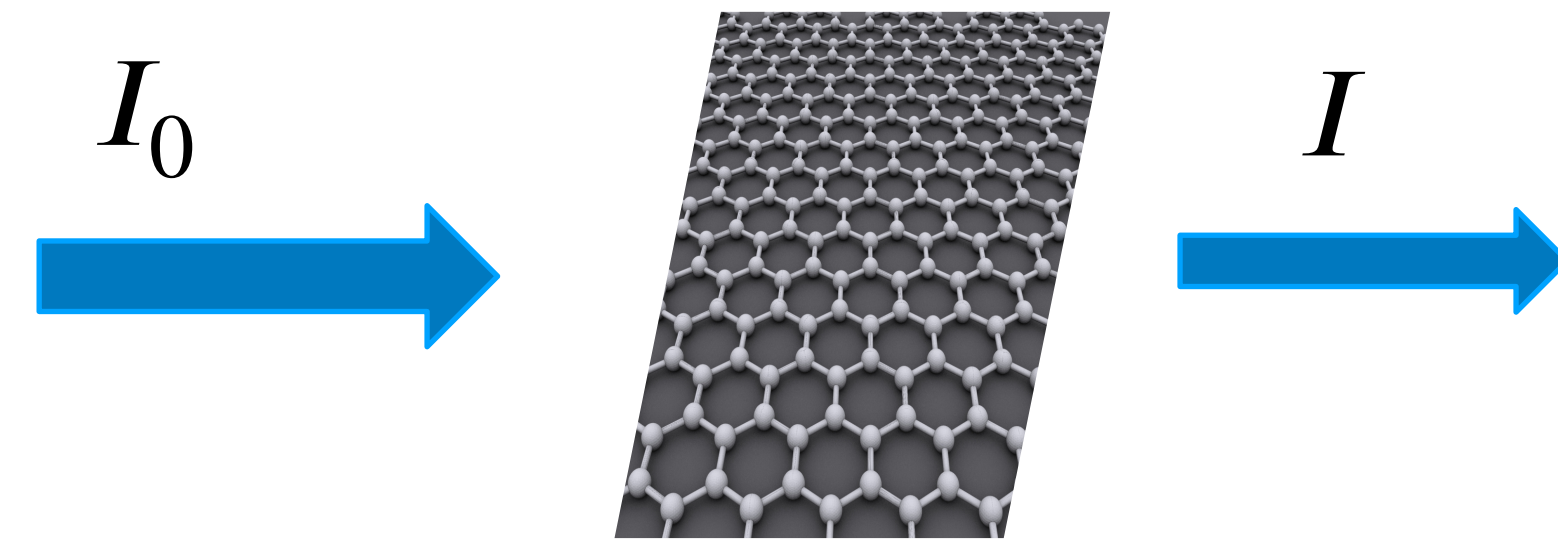


$$I(E) = I_0 e^{-\frac{d}{\lambda_{EAL}}}$$

Which thickness d should be used for ML graphene?

- ❖ Interplanar distance in graphite: 3.35 Å
- ❖ Twice the radius of covalent bond: 2.48 Å

The attenuation length affected by the arbitrariness of the thickness choice

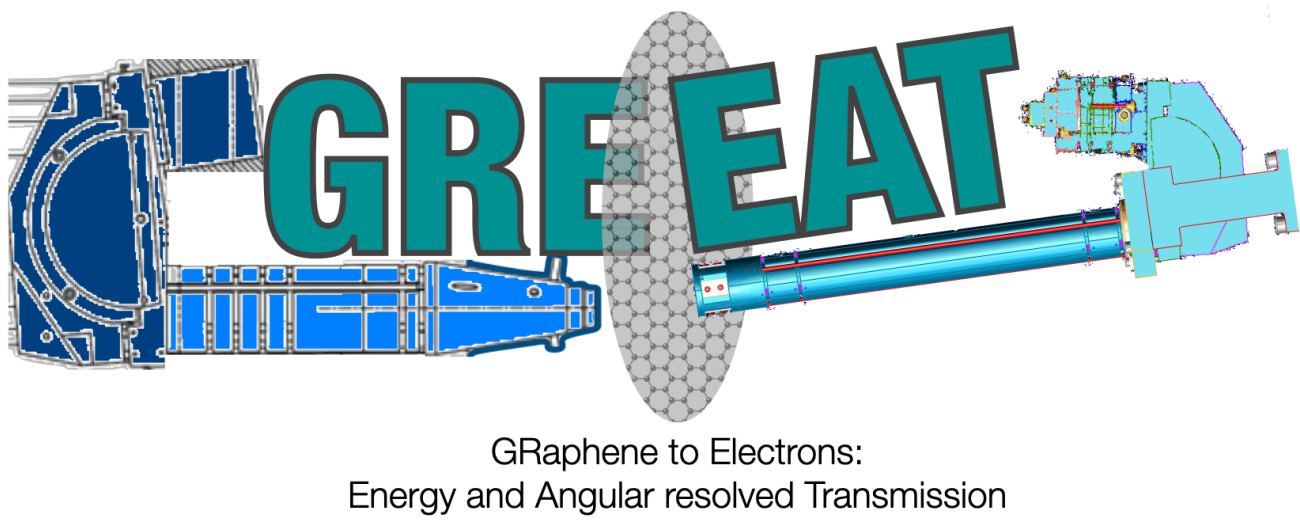


$$I(E) = I_0 e^{-n_G \sigma_{tot}(E)}$$

- ❖ n_G is the surface density of the carbon atom in graphene
- ❖ σ_{tot} is the total cross section

A correct measurement of the non scattered electrons $I(E)$ allows to obtain the total cross section

To Conclude



The GREAT project:

- ❖ Graphene-electrons **cross-section** measured for the **first time**
- ❖ Fundamental for **applications**: MPGD, PTOLEMY

The GREAT project **reinforces** the LASEC lab. (Univeristà Roma Tre) involvement in **INFN activities**

